

Report No.: PNS230710077 01001



Applicant's name:	INMOTION TECHNOLOGIES CO., LTD.	
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Manufacturer name:	INMOTION TECHNOLOGIES CO., LTD.	
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Factory's name:	DONGGUAN BLC ROBOT CO.,LTD.	
Address	Room 201, Building 1, No.2, Youlian Road, Qiaotou Town Dongguan, Guangdong, China	
Testing laboratory:	GUANGDONG UTL CO., LTD.	
Address:	Lianding Testing Building, No.18 Center Road of Yayuan Industrial Zone, Nancheng District, Dongguan, Guangdong, China	
Test item description:	Electric Scooter	
Model/Type reference:	RS series (RS maybe followed by letter, number or blank.)	
Trademark:		
Ratings:	input: 84V, 5A	C
Sample No	 SLine-1-1 & SLine-1-2 for Electric unicycle, SLine-2-1 ~ SLir for Battery 	ne-2-5
Total pages:	85	
Test item:	See next page for details	
Test standard:	ANSI /UL-2272: February 25, 2019	
Test result:	Pass	
Date of receipt of sample:	2023-07-22	Ċ
Date(s) of performance of test:	2023-07-24 to 2023-08-10	
	IN BO	
Tested: Benny Xu	Checked: Ivy Bi Approved: Andy Huang	
Date: 2023-08-15	Date: 2023-08-15 Date: 2023-08-15	



Report No.: PNS230710077 01001

Page 2 of 85

No.	UL 2272 Section	Test Items	Verdicts
1	25	SHORT CIRCUIT TEST	Р
2	27	TEMPERATURE	Р
3	28	DIELECTRIC VOLTAGE WITHSTAND TEST	Р
4	33	VIBRATION TEST	Р
5	34	SHOCK TEST	Р
6	35	CRUSH TEST	P
7	36	DROP TEST	P
8	37	MOLD STRESS RELIEF TEST	Р
9	38	HANDLE LOADING TEST	Р
10	39	MOTOR OVERLOAD	Р
11	40	MOTOR LOCKED ROTOR TEST	Р
12	42	WATER EXPOSURE TEST	P
13	43	THERMAL CYCLING TEST	Р
14	24	Overcharge Test	Р
<u> </u>	26	Overdischarge Test	Р
16	28	Imbalanced Charging Test	Р
No.	UL 2580 Section	Test Items	Verdicts
17	B2.7	SHORT CIRCUIT TEST:	P
18	B2.8	OVERCHARGE TEST:	P
19	B2.5	HEATING TEST:	Р
20	B2.10	PROJECTILE TEST:	Р
Possible	test case verdicts:		
		e test object:	N/A





Report No.: PNS230710077 01001

- Test obje	ect does meet the requ	irement:	<u></u>	P (Pass)
- Test obje	ect does not meet the	requirement:	Chine -	F (Fail)
Model diffe	erence and remark:			
N/A				







Report No.: PNS230710077 01001

SHORT CIRCUIT TEST UL 2272,25

METHOD

A fully charged sample of the DUT was to have the battery terminals short-circuited by connecting the positive and negative terminals of the battery with a circuit load having a total resistance of less than or equal to $20 \text{ m}\Omega$.

Prior to subjecting the DUT to the external short, it was subjected to a single fault across any protective device in the load circuit of the battery.

Protective devices that were determined reliable remained in the circuit for the test.

The DUT was under load until:

- It had returned to ambient temperature or
- Fire or explosion occurred.
- Or a maximum of 3 hours

Temperatures were measured on the DUT battery for monitoring purposes.

If the DUT was operational after the test, the external short was removed and the DUT was subjected to a minimum of one charge/discharge cycle at the manufacturer's maximum specified values. The test was followed by an observation period.

If a protective device in the circuit operated, the test was repeated at 90% of the trip point of the protection device or at some percentage of the trip point that allows discharging for at least 10 min.

At the conclusion of the test and after cooling to near ambient, a DUT that contained hazardous voltage circuits was subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test (without humidity conditioning).



Report No.: PNS230710077 01001

Page 5 of 85

Test Date Laboratory A Model No.:	rehieret 00	\mathbb{O}^{+}					
			\bigcirc	2023-08-02		0.	
Model No.:	Implent, °C			26.7			
			<u>.</u>	LR1726V 🔬	\.	<u>.</u>	
					>		
Sample	Short Circuit	Short	Fault	Max	Measured	Protection	Results
No.		Location	Condition	Measured	Ext.	Tripped,	
				Temp on	Resistance,	Y or N?	
				battery, °C	mΩ		
SLine-2-3		A	Short Q59	27.9	19.5	Y(F2,F3 open)	N
SLine-2-4		В	Short Q1	27.7	19.5	Y(F1 open)	N
					Meas.		
					Current, A		
SLine-2-5	Repeat at 90% Trip point current	A	Short Q59	40.8	234&	Y(F2,F3 open)	N
		\sim		5		-	
\bigcirc		2.	Resu	llts Key		\bigcirc	
N – no fire. r	no explosion. n	o leakade, n			mained intact if	applicable	
	onal after test		/ /				
	nce of fire and/c	or explosion					
R – evidence		·			\$ }		l.
	e of external lea	akage	Û	Û.			
	e of insulation b		electric shock	(hazard)			
X – Other (e							
Short Locati		<u> </u>		6			>
$\langle \rangle$	ack output term	inals	Ø,		\bigcirc	\bigcirc	
B: Scooter in	-						
	outputs if applic	able					
5			\wedge	Á	2		



Report No.: PNS230710077 01001

Page 6 of 85

			nsulation Check		
	Sample No.	Dielectric Voltage	Insulation	Resistance	Dielectric
		Withstand Test	Resistance	Measured, Ohms	Breakdown, Y or
	~	Voltage, V	Voltage, Vdc		N?
$\langle \rangle$	SLine-2-3	168Vdc			N A
V	SLine-2-4	168Vdc	0.	0	N V
	SLine-2-5	168Vdc			Ν

As a result of the short circuit test, there [was] [was no] evidence of:

- a) Explosion;
- b) Fire;
- d) Rupture (enclosure);
- e) Electrolyte Leakage (external to enclosure.

[X] There [was] [was no] evidence of an electric shock hazard introduced as a result of the short circuit test.

[] The insolation resistance [was] [was not] less than 50,000 Ω

&: Short Q59 Max. trip current is 260A,Test was repeated at 90% of the trip point of the protection device: 260A X 90%=234A.





Report No.: PNS230710077 01001

Page 7 of 85

TEMPERATURE UL 2272,27

METHOD

A fully discharged DUT (i.e. discharged to EODV) was conditioned within a chamber set to the upper limit charging temperature specifications of the DUT. After thermal stabilization in the chamber, the DUT was connected to a charging circuit input representative of anticipated maximum charging parameters. The DUT was then subjected to maximum normal charging while monitoring voltages and currents on cells until it reached the manufacturer's specified fully charged condition.

Temperatures were monitored on temperature sensitive components including cells and on any user accessible surfaces.

While still in the conditioning chamber, and after allowing temperatures to stabilize, the fully charged DUT was then discharged in accordance with the manufacturer's specifications down to the manufacturer's specified end of discharge condition while monitoring voltage and current on cells until the DUT reached its specified EODV. Temperatures were monitored on temperature sensitive safety critical components including cells and on any user accessible surfaces.

Note: The method of simulating the maximum continuous electrical load for discharging the batteries may vary according to the scooter design and should be a method agreed upon by the manufacturer and organization testing the scooter. The methods to simulate this loading can include the use of a dynamometer or other mechanical loading means, or manipulation of the electrical and electronic control circuit(s) to simulate loading on the motor. Factors to be considered when determining the maximum continuous electrical load during discharge include maximum weight of rider, maximum speed of movement, angle of movement and loads from auxiliary devices such as lights, audio, etc. that may be operating when the scooter is moving. If there is a need to consider the surface impact to loading, concrete is to be used to represent typical outdoor operating surfaces.

The charge and discharge cycles were then repeated for a total of 2 complete cycles of charge and discharge in the maximum ambient.

During the temperature test, the voltage, temperature and current during discharge and charging of the component cells was monitored to determine that the values were not outside of the specified cell manufacturer's operating region.

At the conclusion of the observation period, the samples with hazardous voltage circuits were subjected to an Isolation Resistance Test (without humidity conditioning) or a Dielectric Voltage Withstand Test.



Report No.: PNS230710077 01001

Page 8 of 85

RESULTS

DUT: V11				
Specified Max. Charging Ambient, °C:		40		
Specified Max. Operating Ambient, °C	:	40		
Maximum specified rider weight, lbs		150		
Determined maximum continuous	discharge current	100		- S
based upon loading considerations, A				
Method to achieve maximum conti	nuous discharge			
current load on sample:				
Sample No.		SLine-1-1		
Test Date		2023-07-31 to	2023-08-03	
Room Ambient, °C:		26.1/26.5/24.	7/26.5	

Location of			Max	imum Mea	sured Terr	nperatures	, °C		Ś
Thermocouple		Disch	narging			Cha	rging		Spec. Limit
	25 .	⊧5°C	Max A	mbient	25 1	±5℃	Max A	mbient	
Cycle No.	1	2	1	2	1	2	1	2	
1.Battery charge wire	56.1	56.1	69.6	69.6	32.8	32.0	46.7	47.3	80
2.Battery charge connector	60.5	60.3	74.0	73.8	30.1	29.0	44.0	44.3	80
3.Battery discharge connector	62.0	62.4	75.5	75.9	31.9	30.7	45.8	46.0	130
4.Battery discharge wire	63.2	63.1	76.7	76.6	32.7	31.7	46.6	47.0	80
5.Battery PCB near Q71, Q72	72.8	73.2	86.3	86.7	46.3	45.9	60.2	61.2	105
6.Battery PCB near Q65, Q66	66.7	66.8	80.2	80.3	72.6	72.0	86.5	87.3	105
7.Battery PCB near R280, R281	75.8	76.2	89.3	89.7	41.2	40.6	55.1	55.9	105
8.Cell 1	64.5	63.8	68.0	77.3	32.8	31.8	46.7	47.1	70
9.Cell 2	65.3	64.4	68.8	77.9	32.4	31.2	46.3	46.5	70
10.Cell 3	64.6	63.6	68.1	77.1	30.7	31.5	44.6	46.8	70
11.Cell 4	65.5	64.7	69.0	78.2	32.5	31.5	46.4	46.8	70
12.Battery PCB near U1	71.2	71.3	84.7	84.8	38.2	37.2	52.1	52.5	105
13.C65	57.7	56.6	71.2	70.1	27.3	25.9	41.2	41.2	105
14.Main board	69.1	67.9	82.6	81.4	26.9	25.8	40.8	41.1	105



Report No.: PNS230710077 01001

Page 9 of 85

PCB near									
MOS12,MOS17	E1 4	EO O	64.0	69.0	26.8	05.0	40.7	40.0	65
15.Motor connector	51.1	50.3	64.6	63.8		25.6		40.9	
16.Main board PCB near U1	58.4	56.9	71.9	70.4	26.6	25.5	40.5	40.8	105
17.Motor wire	53.6	52.7	67.1	66.2	26.8	25.5	40.7	40.8	80
18.Input	42.0	41.1	55.5	54.6	28.0	26.3	41.9	41.6	80
Charging Terminal	S S						- Chille	a P	
19.Plastic enclosure inside	32.3	31.4	45.8	44.9	26.2	24.9	40.1	40.2	85
20.Plastic enclosure outside	28.6	29.0	42.1	42.5	26.2	24.8	40.1	40.1	85
21.Metal	38.0	36.9	51.5	50.4	26.7	25.8	40.6	41.1	70
enclosure outside near battery and Controller		<u></u>	<	O>					
22.Motor 1 winding	65.0	61.7	78.5	75.2	27.1	25.5	41.0	40.8	105
23.Motor 1 winding	64.9	61.5	78.4	75.0	26.9	25.4	40.8	40.7	105
24.Motor 1 winding	64.4	60.8	77.9	74.3	26.8	25.3	40.7	40.6	105
25.Motor 1 PCB	64.5	60.6	78.0	74.1	26.5	25.4	40.4	40.7	130
26.Motor 1 inside wire	58.4	55.0	71.9	68.5	26.4	25.2	40.3	40.5	105
27.Motor 2 winding	85.8	86.1	99.3	99.6	27.6	27.5	41.5	42.8	105
28.Motor 2 winding	84.9	85.2	98.4	98.7	27.4	27.4	41.3	42.7	105
29.Motor 2 winding	83.6	83.7	97.1	97.2	27.8	26.8	41.7	42.1	105
30.Motor 2 PCB	83.8	84.6	97.3	98.1	27.6	27.1	41.5	42.4	130
31.Motor 2 inside wire	77.2	77.0	90.7	90.5	27.5	26.6	41.4	41.9	105
32.LED light	34.2	33.1	47.7	46.6	26.8	25.2	40.7	40.5	120
33.Handle	28.1	29.3	41.6	42.8	26.5	24.8	40.4	40.1	85
34.Ambient	26.5 Min	26.5 Measure	40.0	40.0	26.1	24.7 K Measured	40.0	40.0	
	2.984	2.950			4.198	4.198		vuc	
Cell No 1 Cell No 2	2.982	2.924		<u> </u>	4.196	4.197		<u> </u>	Charg e:4.3
Cell No 3	3.044	3.010			4.200	4.200			25V
Cell No 4	2.959	2.910			4.200	4.200			Disch
Cell No 5	3.022	2.991			4.202	4.202			arge:
Cell No 6	3.059 3.004	3.015 2.972			4.203 4.209	4.204 4.200			2.5V
Cell No 7 Cell No 8	3.029	2.972			4.209	4.200			-
		Ś	1		1	- ÂS			1



Report No.: PNS230710077 01001

Page 10 of 85

									charg e:5.0 A
Battery current	60.8	60.2			4.95	4.96	- Star		Disch arge curre nt:10 0A/
		as. Discha	arge Curre	ent, A		Meas. Cha	rge Curre	nt, A	
Cell No 20	3.052	2.924			4.200	4.199			
Cell No 19	3.015	2.943			4.205	4.200		0	
Cell No 18	2.959	2.983		<u> </u>	4.203	4.198			
Cell No 17	3.038	2.972			4.202	4.200			
Cell No 16	3.029	2.986			4.197	4.201			
Cell No 15	2.999	2.980			4.197	4.197			
Cell No 14	3.054	3.008			4.206	4.204	- C		
Cell No 13	3.022	2.985			4.201	4.202			
Cell No 12	2.956	2.915			4.200	4.197			
Cell No 11	3.044	3.005		· ·	4.200	4.197		<u> </u>	
Cell No 10	2.977	2.931			4.197	4.197			
Cell No 9	2.981	2.955			4.196	4.196			

The cell manufacturer's specified limits (voltage, current and temperatures measured) [were] [were not] exceeded during the charging and discharging cycles.

Temperatures measured on components [did] [did not] exceed their specifications.



Page 11 of 85

Report No.: PNS230710077 01001

DIELECTRIC VOLTAGE WITHSTAND TEST UL 2272,28

METHOD

DUTs with circuits at 60 Vdc (or 30 Vrms / 42.4 Vpk) or higher were subjected to a dielectric withstand voltage consisting of one of the following:

1) for dc circuits isolated from mains -

- a dc potential of twice the rated voltage of the circuit under test, or
- an essentially sinusoidal ac potential of frequency between 40 70 Hz at twice rated voltage of the circuit under test

2) for ac circuits or dc circuits not isolated from mains -

- an ac potential of 1000 plus two times the voltage of the circuit under test or
- a dc potential of 1.414 times 1000 V plus two times the voltage of the circuit under test

The test voltages were applied for a minimum of 1 minute with the cells disconnected to prevent charging during application of the voltage.

Semiconductors or similar electronic components not relied upon for protection from electric shock and liable to be damaged by application of the test voltage were bypassed or disconnected.

The test voltage was applied between the hazardous voltage circuits of the DUT and non-current carrying conductive parts that were accessible. The test voltage was also applied between the hazardous voltage charging circuit and the enclosure/accessible non-current carrying conductive parts of the DUT.

If accessible part of the DUT were covered with insulating material that could become live in the event of an insulation fault, then the test voltages were applied between each of the live parts and metal foil in contact with the accessible parts. The metal fail was drawn tightly across any opening in the enclosure or other accessible parts to form a flat plane across such an opening per the figure below.

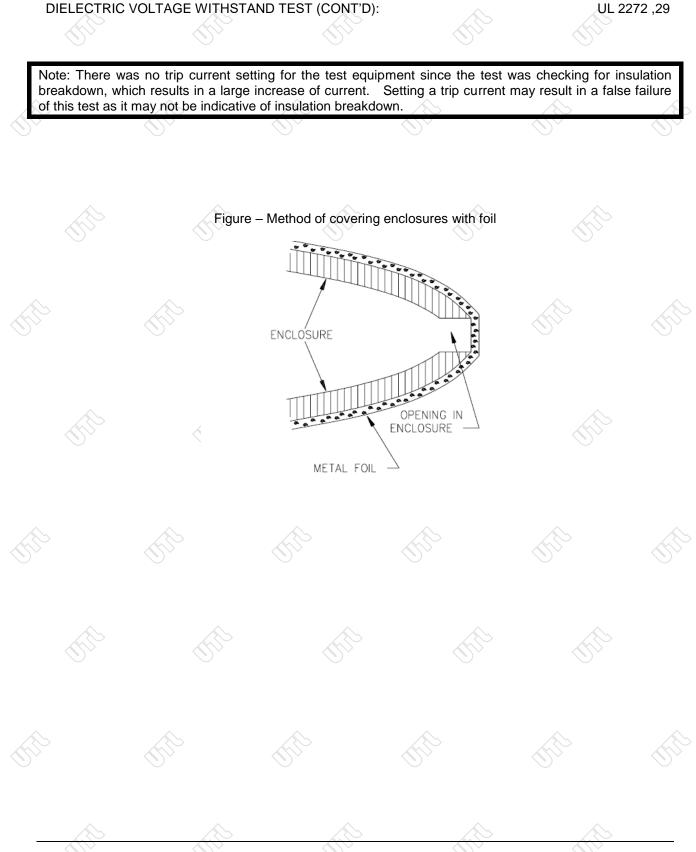
The test equipment used consisted of a 500 VA or larger capacity transformer, the output voltage which is variable and which was essentially sinusoidal if using the ac test method or a dc output if using the dc tests method.





Report No.: PNS230710077 01001

Page 12 of 85



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Page 13 of 85

Report No.: PNS230710077 01001

DIELECTRIC VOLTAGE WITHSTAND TEST (CONT'D):

UL 2272 ,29

RESULTS

DUT:		RS	
Test Date		2023-07-24	
Lab Ambient, °C		27.5	
Sample No.		SLine-1-2	

Location of in	sulation under test		Test Potential [Vdc][Vac]	Breakdown? Y or N
Insulation between accessible parts	positive terminal	and	168	N
Insulation between accessible parts	negative terminal	and	168	N
Insulation between accessible parts	charging circuit	and	168	N

As a result of applied potential, there [was] [was no] evidence of dielectric breakdown between the locations tested.

Note: Evidence of dielectric breakdown (breakdown of insulation resulting in a short through insulation/arcing over electrical spacings) was evidenced by an appropriate signal form the dielectric withstand equipment as a result of the applied test voltage. Corona discharge or a single momentary discharge was not regarded as a dielectric breakdown (i.e. insulation breakdown).





Page 14 of 85

Report No.: PNS230710077 01001

VIBRATION TEST UL 2272,33

METHOD

The test was performed in accordance with one of the following methods:

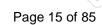
- the Standard for Batteries for Light Electric Vehicles, UL 2271, Section 30, Vibration Endurance Test without the temperature variation (refer to ISO 12405-1 random vibration method), or
- According to a test profile determined by the customer and verified to the LEV application.

The fully charged DUT was securely mounted to a vibration test platform. The DUT was subjected to a vibration along three perpendicular axes.

If conducting the ISO 12405-1 random vibration method (without temperature variation), the DUT was subjected to the vibration in each axis for 21 h if testing one sample, 15 h if testing two samples or 12 h if testing 3 samples. For each axis the frequency was varied from 5 Hz to 200 Hz with power spectral density (PSD) as outlined in the Table below.

Axis		Frequency	PSD	PSD
		Hz	g²/Hz	(m/s²)²/Hz
Z (vertical)		5	0.05	4.81
		10	0.06	5.77
~		20	0.06	5.77
		200	0.0008	0.08
		rms	1.44 g	14.13 m/s ²
Y (transverse)		5	0.04	3.85
		10		
		20	0.04	3.85
		200	0.0008	0.08
		rms	1.23 g	12.07 m/s ²
	\bigotimes	\sim	\sim	\sim
X (longitudinal)		5	0.0125	1.20
		10	0.03	2.89
		20	0.03	2.89





Report No.: PNS230710077 01001

Â	200	0.00025	0.02
	rms	0.96 g	9.42 m/s²

If the DUT was operational after the test, it was subjected to a minimum of one discharge/charge cycle at the manufacturer's maximum specified values. If not operational, a charge was attempted. The test shall be followed by a one hour observation period.

At the conclusion of the observation period, the samples with hazardous voltage circuits shall be subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test (without humidity conditioning).





Report No.: PNS230710077 01001

Page 16 of 85

	RESULTS
DUT:	RS
Test Date	2023-07-25 to 2023-07-28
Lab Ambient, °C	27.2/26.8/27.4/27.6
Vibration Method Used for Test:	[random][specific to scooter]
Dielectric voltage test value, V	168Vdc
Isolation resistance Voltage, Vdc	

	Sample	Initial OCV,	Final OCV, Vdc	Max Temp on	Length of	Results	
	No.	Vdc	\bigcirc	Cell/Mod, °C	vibration, h		
;	SLine-1-2	83.3	83.2		21h(Axis: Z)	N,O	
;	SLine-1-2	83.2	83.0		21h(Axis: Y)	N,O	
	SLine-1-2	83.0	83.0	^	21h(Axis: X)	N,O	~
		Dielectric Voltage N	e Breakdown Y or	Measured Isolatic	on Resistance Ω		
;	SLine-1-2	Ν					

	Results Key
E – Explosion	L – Electrolyte Leakage (external to enclosure)
F - Fire	S – Electric shock (dielectric breakdown or resistance below
	isolation resistance limits
R – Rupture	N - No evidence of noncompliant results
O – Operational after test	

[] See also attached vibration spectra for details of vibrations applied.

As a result of the vibration, the samples [did] [did not] catch fire or explode during the test or at the conclusion of the rest period. There [was] [was no] evidence of electrolyte leakage or signs or rupture of the battery enclosure.

[X] There [was] [was no] evidence of [dielectric breakdown]

[] The insolation resistance [was] [was not] less than [50,000 Ω].



Report No.: PNS230710077 01001

Page 17 of 85

SHOCK TEST UL 2272,34

METHOD

A fully charged sample of the personal e-mobility device was secured to the testing machine by means of a rigid mount, which supported all mounting surfaces of the sample. Temperatures on the center cell were monitored for information purposes.

The sample was subjected to mechanical shock testing with parameters as shown in Table below or according to a test profile determined by the customer and verified to the personal e-mobility device application. When considering the level of shock, the weight of the DUT and maximum specified weight of the rider was considered.

The battery was tested first separately from the personal e-mobility device with the higher shock levels for lighter devices noted in the Table prior to testing the complete assembly. The shocks were applied in all 6 spatial directions.

DUT and Maximum Allowed Rider Weight	Pulse shape	Acceleration	Duration	Number of shocks
<u>≤ 12 kg</u>	half-sinusoidal	50 g -	11 ms -	3 ⊥ directions
<mark>> 12 ≤ 100 kg</mark>	-	25 g -	15 ms -	3 ± directions
> 100 kgª	- 1	10 g	20 ms	3 ⊥ directions

Table - Shock parameters

^a Battery pack previously tested individually outside of personal e-mobility device to the appropriate higher shock level per its weight.

If the DUT was operational after the test, it was subjected to a minimum of one charge/discharge cycle at the manufacturer's maximum specified values. If not operational, it was subjected to an attempted charge only. The test was followed by a 1 hour observation period.

At the conclusion of the observation period, the samples with hazardous voltage circuits were subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test without humidity conditioning.

Note: DUT> $12 \le 100$ kg, and Maximum Allowed Rider Weight>100 kg, so test condition pick the second and third from Table – Shock Parameters.



Report No.: PNS230710077 01001

Page 18 of 85

[X] The sample was examined with the probe of 9.1.3 to determine if it was possible to access hazardous parts if applicable.

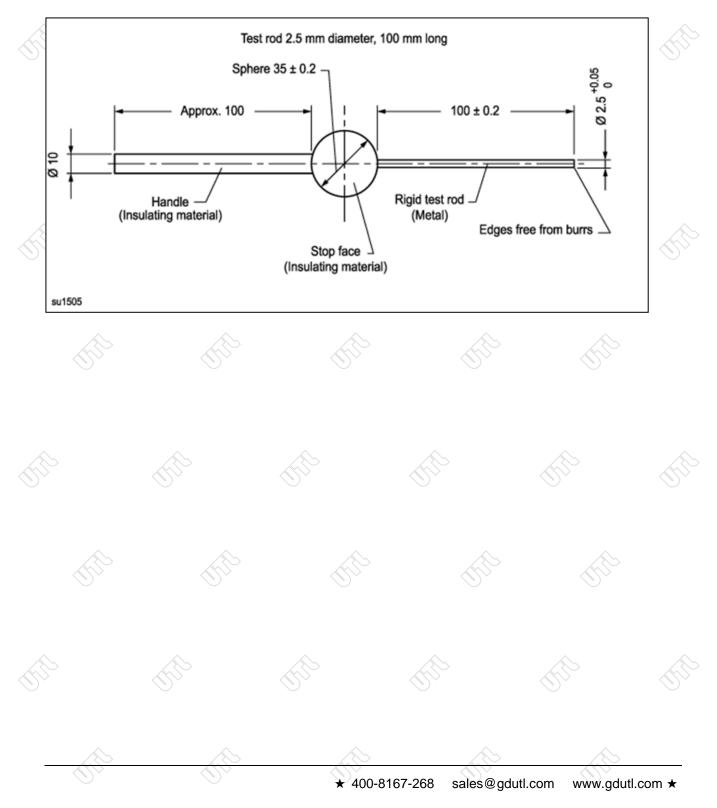


Figure – IEC 2.5 mm diameter test rod



Report No.: PNS230710077 01001

Page 19 of 85

		RESULTS
	DUT:	LR1726V / RS
	Test Date:	2023-07-24
\langle	Lab Ambient, °C	26.7
\rangle	Weight of DUT, kg	LR1726V:16.05
	Maximum Rider Weight, kg	RS:58
	Dielectric voltage test value, V	150
	Isolation resistance Voltage, Vdc	168Vdc

	/					
Sample	Initial OCV,	Final OCV,	Max Temp on	Length of	Test	Results
No.	Vdc	Vdc	Cell/Mod, °C	shock, h	Condition	
SLine-1-	83.2	83.2			С	N,O
2			~			
SLine-2-	83.3	83.3			A	N,O
3				<u> </u>		
	Dielectric	Voltage	Measured	Isolation		
	Breakdown? Y	′ or N	Resistance, Ω			
SLine-1-		N	-	-		
2						
SLine-2- 3	<	N >>		-		

Test Condition:

Condition A: shock at 50 g, 11 ms; Condition B: shock at 25 g, 15 ms;

Condition C: shock at 10 g, 20 ms;

	Resu	Its Key		\bigcirc
E – Explosion	L – Electrolyt	e Leakage (external to	o enclosure)	
F - Fire	S – Electric isolation resis	shock (dielectric br stance limits	eakdown or resista	nce below
R – Rupture	N - No evider	nce of noncompliant re	esults	
O – Operational after test			.50113	

[] See also attached shock waveforms for details of shocks applied.

As a result of the shock, the samples [did] [did not] catch fire or explode during the test or at the conclusion of the rest period.





Report No.: PNS230710077 01001

Page 20 of 85

There [was] [was no] evidence of electrolyte leakage or signs or rupture of the battery enclosure.

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Report No.: PNS230710077 01001

Page 21 of 85

CRUSH TEST UL 2272,35

METHOD

A fully charged DUT was subjected to a crush test as outlined below. One sample of the DUT was to be supported on a fixed rigid supporting surface, in the position and orientation that is representative of operation. A crushing force was applied to the foot support surface by two flat applicator plates each sized 102 by 254 mm (4 by 10 inches). A force of 2 times the maximum specified rider weight was evenly distributed between the two applicator plates to the scooter foot support surface. The total weight of the force applied to the foot support surfaces included the weight of the flat applicators.

The test force was held in place for a minimum of one minute. The force was then removed. If the DUT was operational after the test, it was subjected to a minimum of one charge/discharge cycle at the manufacturer's maximum specified value. The DUT was then subjected to a 1 hour observation period.

The DUT with hazardous voltage circuits was subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test (without humidity conditioning). The sample was examined with the probe of 8.1.3 (2.5 mm diameter test rod) to determine if it is possible to access hazardous parts if applicable.



Report No.: PNS230710077 01001

Page 22 of 85

RE	SULTS
DUT:	RS
Test Date	2023-07-31
Test Ambient, °C	26.2
Max Specified Rider Weight , kg	150
Dielectric voltage test value, V	168Vdc
Isolation resistance voltage applied, Vdc	

	Sample No.	OCV at start, Vdc	Test Weig kgs	jht,	Operational after crush,	J.	Results	
-	SLine-	83.1	300kg		Y or N Y		N,O	
	1-2			\land		\sim		
57	Dielectric V		Itage Measured Isolation		ured Isolation	5>-		
		Breakdown?	Y or N R		esistance, Ω			
	SLine- N 1-2							
			\wedge	~		\land		~
		>		F	Results Key			
	E – Explo	osion	S – Electr	ic shoc	k (dielectric b	reakdown or	resistance b	elow isolation
	resista		resistance l	esistance limits or exposure of live parts)				
	F - Fire		N - No evid	ence of	noncompliant r	esults		
	L – Leaka	age	R – Rupture	e 🔨				
57			O – Operati	ional aft	er test			

The sample [did] [did not] explode or catch fire. There [was] [was no] evidence of rupture or leakage.

[X] There [was] [was no] evidence of dielectric breakdown.

[] The insolation resistance [was] [was not] less than 50,000 Ω .

[X] There [was] [was no] exposure of hazardous parts.

Note:150kgX2 times =300kg



Report No.: PNS230710077 01001

Page 23 of 85

DROP TEST UL 2272.36

METHOD

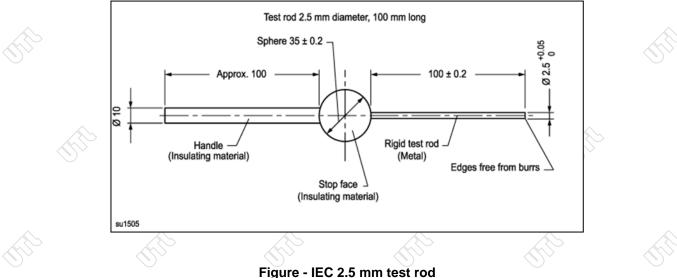
A fully charged DUT was dropped three times from a height of 1.0 \pm 0.01 m (39.4 \pm 4 in) to strike a concrete surface in a manner most representative of what would occur during lifting or handling of the DUT by the user. The concrete surface was at least 75 mm (3 in) thick and was large enough in area to cover the DUT.

DUTs employing plastic enclosures were conditioned for a minimum of 3 h at 0°C (32°F) or temperature specified if lower than 0°C (32°F) prior to conducting the drop test, which was conducted immediately after removing the samples from the cold conditioning.

If the DUT was operational after the test, it was subjected to a discharge/charge cycle per the manufacturer's specified values. If the sample was not operational, it was still subjected to an attempted charge. The test was followed by a 1 hour observation period. The sample was then examined using the 2.5 mm test rod probe and the articulate probe for damage that could result in access to hazardous parts.

After examination, the DUT with hazardous voltage circuits was subjected to a dielectric voltage withstand test or isolation resistance test (without humidity conditioning).

ACCESSIBILITY PROBES:

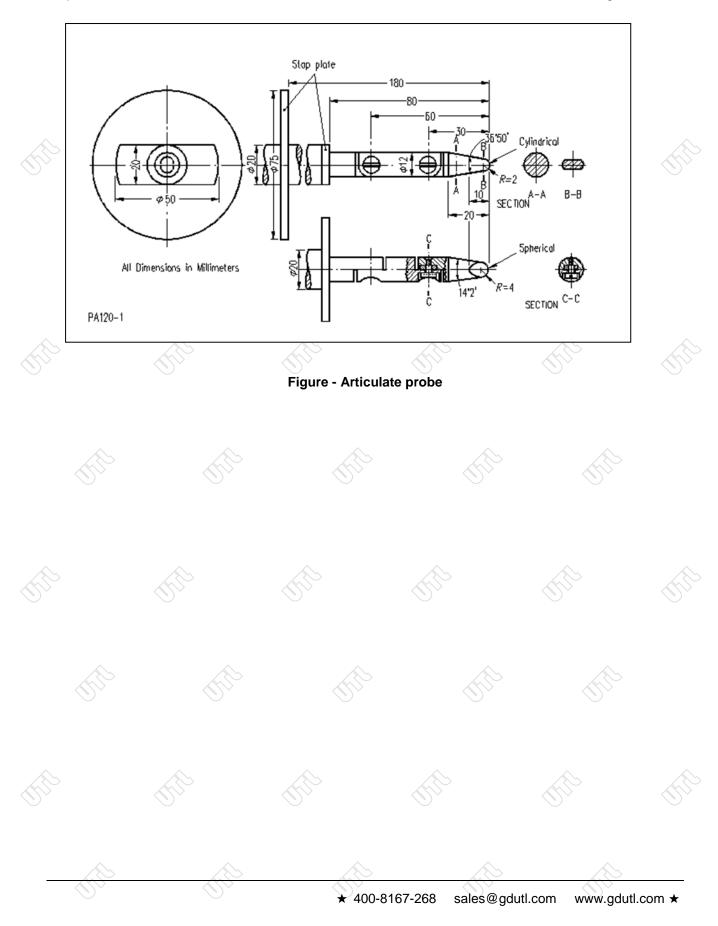


Note: The handle dimensions (ø 10 and 20) are not critical.



Report No.: PNS230710077 01001

Page 24 of 85





Report No.: PNS230710077 01001

Page 25 of 85

RESULT	ſS
DUT:	RS
Test Date:	2023-08-09
Test Ambient, °C	27.2
Dielectric voltage test value, V	168Vdc
Isolation resistance limit, $\Omega/\Omega/Vdc$	N/A
Test Chamber Temperature, °C	-10

Sample	OCV at start	Location of D	rop	Accessibility Probe:	Results	
No.	of test, Vdc			[2.5 mm test rod]/	\bigcirc	
				[articulate finger]		
SLine-1-	83.3	Тор		Failed to dangerous	N,O	
2				touch parts of the interior		
SLine-1- 2	\\	Bottom		Failed to dangerous touch parts of the interior	N,O	
SLine-1- 2	83.2	Side		Failed to dangerous touch parts of the interior	N,O	
	Dielectric Volta	ge Breakdown? Y	Measu	red Isolation		
		or N	Resist	ance, Ω		
SLine-1- 2		Ν				
~	\sim		•			

	Results Key
E – Explosion	L – Electrolyte Leakage (external to enclosure)
F - Fire	S – Electric shock (dielectric breakdown or resistance below isolation resistance limits
R – Rupture	A – Hazardous parts accessible
O – Operational after testing	N - No evidence of noncompliant results

As a result of the drop impact, the DUT [did] [did not] catch on fire or explosion. There [was] [was no] evidence of leakage of electrolyte.

There [was] [was no] rupture of the enclosure that would result in access to hazardous parts.



Page 26 of 85

Report No.: PNS230710077 01001

[X] There-[was] [was no] evidence of dielectric breakdown.

[] The insolation resistance [was] [was not] less than 50,000 Ω .





Page 27 of 85

Report No.: PNS230710077 01001

MOLD STRESS RELIEF TEST UL 2272,37

METHOD

A sample was subjected to the mold stress test as in accordance with the method outlined in UL Subject 2271, Section 8.6.

A discharged battery DUT was placed in a full-draft circulating-air oven maintained at a uniform temperature of 70°C (158°F) or 10°C (18°F) plus the maximum temperature (T) measured on the polymeric enclosure materials during the temperature test of 26, whichever was the highest temperature.

The sample remained in the oven for 7 h.

After careful removal from the oven and return to room temperature, the DUT was examined for evidence of mechanical damage, such as cracking or warping of the enclosure or openings created that would allow access to hazardous parts using the 2.5 mm test rod probe and articulate probe as noted under GENERAL.

A DUT with hazardous voltage circuits was subjected to a dielectric voltage withstand test or an isolation resistance test (without humidity conditioning).



Report No.: PNS230710077 01001

Page 28 of 85

		RE	SULTS		> <u></u>
DUT:			RS	\bigcirc	O.
Test Date			2023-08-08		
Maximum enclosure to temperature test, °C	emperature m	neasured in	45.8		
Test Chamber Ambient	, °C	<u> </u>	70		
Lab Ambient, °C			26.5		
Isolation resistance limi	t, Ω/ Ω/Vdc				
Dielectric voltage test v	alue, V		168Vdc		
Probe Used	\bigcirc		[2.5 mm roc	[][articulate	probe]
Sample	Dielectric	Voltage	Measured	Isolation	Hazardous Part Accessible?
~	Breakdown?	Y or N	Resistance,	Ω	Y or N
SLine-1-2	Ν			<u> </u>	N

After careful removal from the oven and return to room temperature, the sample [did] [did not] show evidence of mechanical damage, such as cracking or warping of the enclosure or openings created that would allow access to cells and protection circuits with the test probes.

[X] There [was] [was no] evidence of dielectric breakdown.

[] The insolation resistance [was] [was no] less than 50,000 $\Omega.$

Note: Plastic Enclosure maximum temperature (T)45.8°C+10=55.8°C, or 70°C, whichever was the highest temperature.



Report No.: PNS230710077 01001

HANDLE LOADING TEST:

Page 29 of 85

UL 2272,38

METHOD

A force was applied on the handle in the intended carrying direction uniformly over a 75-mm (2.95-in) length at the center of the handle. The applied force was gradually increased from zero to four times the weight of the DUT in 5 - 10 s and then maintained at the level for 1 min.

If more than one handle was provided, the test force applied to each handle was based upon the percentage of the DUT weight sustained by each handle with the DUT in the intended carrying position. Each handle was then subjected to a weight of four times the determined weight for that handle.

If a DUT weighing less than 25 kg (55.1 lbs) was provided with more than one handle and could be carried by only one handle, each handle was subjected to a force based on the total weight of the DUT (for a total of four times the DUT.

RESULTS

DUT:	RS	
Test Date	2023-08-07	
Test Ambient, °C	27.2	S>
DUT weight, kg	58	
Number of handles provided on DUT	2	

Sample	Weight Appl	ied to Handle, kg	Results	
SLine-1- 2	No. 1	232	1	
SLine-1- 2	No. 2	232	1	

	Results	Key								
<u> </u>	1 – No	damage to handle or	handle securements	2 –	damage	to	handle	or	handle	securement
K	means			mear	ns 🔊					
	/									

As a result of the applied force, there [was] [was no] evidence of damage to the handle(s) or the handle(s) securement means.

Test force: 58kgX4times=232kg



Report No.: PNS230710077 01001

Page 30 of 85

MOTOR OVERLOAD UL 2272,39

METHOD

[X] The motor was tested while in the scooter and temperatures on windings are to be monitored.

[] The motor was tested outside the scooter.

The motor was first operated under maximum normal load conditions. The load was then increased so that the current was increased in appropriate gradual steps with the motor supply voltage maintained at its original value. When steady state temperature conditions were established, the load was again increased. The load was thus progressively increased in appropriate steps until either the overload protection device operated or the motor winding became an open circuit.

[X] The motor winding temperatures were determined using thermocouples during each steady period and compared to determine that maximum temperatures did not exceed the value in Table 39.1. Note: Motor overload test for normal motor test

[X] The design or size of the motor prevented the measuring of temperature windings. Instead of measuring temperatures the test was conducted with the motor removed from the scooter and supported on a surface covered with a single layer of tissue paper with the DUT covered with a single layer of cheesecloth.

Note: Motor overload test for abnormal motor test

If the DUT contained a hazardous voltage circuit, the DUT it was subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test (without humidity conditioning).

35.7 There shall be no insulation breakdown during the Dielectric Voltage Withstand Test or the isolation resistance shall not be below 50,000 Ω .

	Thermal Class	Class A (105)	Class E	Class B (130)	Class F (155)	
			(120)			\sim
< C	Temperature Limit, °C	140	155	165	190	

Table 39.1 – Motor Winding Temperature Limits during Overload



Report No.: PNS230710077 01001

Page 31 of 85

	RESULTS
DUT:	RS
Test Date	2023-08-05
Test Ambient, °C	27.8
Insulation Class Temperature Limit, °C	140
Dielectric voltage test value, V	168Vdc
Isolation resistance voltage applied, Vdc	N/A

Sample No.	Test: In Scooter or on	Location of Thermocouples	Maximum Temperature on Windings, °C	Ignition of combustibles?
	Bench			Y or N
SLine-1- 1(Normal)	In Scooter, test with power supply and main control board	Motor winding	134.6	N/A
	Dielectric Voltage	Breakdown? Y or	Measured Insulation	Resistance, Ω
SLine-1-1	N			

[X] Temperatures on windings [did] [did not] exceed the values noted in Table 39.1 for the class of insulation.

[] There [was] [was no] sign of ignition of the tissue or cheesecloth at the conclusion of the test.

[X] There-[was] [was no] insulation breakdown during the Dielectric Voltage Withstand Test.

[] The isolation resistance [was] [was not] below the 50,000 ohms.



Report No.: PNS230710077 01001

Page 32 of 85

ARE ARE	SULTS
DUT:	RS
Test Date	2023-08-08
Test Ambient, °C	28.7
Insulation Class Temperature Limit, °C	
Dielectric voltage test value, V	168Vdc
Isolation resistance voltage applied, Vdc	N/A
Abnormal Test	By-pass the over temperature protection

Sample No.	Test:	Location of	Maximum Temperature	Ignition of
	In Scooter or	Thermocouples	on Windings, °C	combustibles?
	on Bench			Y or N
SLine-1-1 (Abnormal)	In Scooter, test with power supply and main control	Motor winding	196.3	N
	Dielectric Voltag	e Breakdown? Y or	Measured Insulation	n Resistance, Ω
SLine-1-1	N			

[] Temperatures on windings [did][did not] exceed the values noted in Table 39.1 for the class of insulation.

[X] There [was][was no] sign of ignition of the tissue or cheesecloth at the conclusion of the test.

[X] There [was][was no] insulation breakdown during the Dielectric Voltage Withstand Test.

[] The isolation resistance [was][was not] below the 50,000 ohms.



Page 33 of 85

Report No.: PNS230710077 01001

MOTOR LOCKED ROTOR TEST UL 2272,40

METHOD

The motor was operated at the voltage used in its scooter application and with its rotor locked for 7 h or until steady conditions were established.

[X] The motor was tested while in the scooter and temperatures on windings were monitored. As an alternative, the motor was tested outside the scooter.

Note: Motor locked rotor test for normal motor test

[X] The test was conducted with the motor removed from the scooter and instead of monitoring temperatures, the DUT was supported on a surface covered with single layer of tissue paper with the DUT covered with a single layer of cheesecloth.

Note: Motor locked rotor test for abnormal motor test

[] The DUT shall be subjected to a Dielectric Voltage Withstand Test or Isolation Resistance Test (without humidity conditioning).

		Temperature	Limits, °C	
Thermal Class	Class A (105)	Class E	Class B	Class F (155)
\sim		(120)	(130)	
Type of Protection:	\mathbb{O}^{\sim}	\bigcirc	\bigcirc	<u> </u>
Protection by inherent or external	150	165	175	200
impedance				
Protection by protective device that operates during the first hour	200	215	> 225	250

Table 40.1 – Motor Winding Temperature Limits during Locked Rotor



Report No.: PNS230710077 01001

Page 34 of 85

 Protection by any protective device: maximum after first hour (automatic) 	175	190	200	225	
maximum after first hour (thermal cutoff)	150	165	175	200	
 arithmetic average during the 2nd hour and during the 72nd 	150	165	175	200	
hour					

























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Report No.: PNS230710077 01001

Page 35 of 85

MOTOR LOCKED ROTOR TEST (CONT'D):

UL 2272,40

RESULTS

DUT:	RS
Test Date	2023-08-07
Test Ambient, °C	26.3
Insulation Class Temperature Limit, °C	200
Type of Locked Rotor Protection:	Over Current protection
Dielectric voltage test value, V	168Vdc
Isolation resistance voltage applied, Vdc	N/A

	Sample No.	Test: In Scooter or on Bench	Location of Thermocouples	Maximum Temperature on Windings, °C	Ignition of combustibles? Y or N
_	SLine-1-1 (Normal)	In Scooter, test with power supply and main control board	Winding	28.9	N/A
S	\diamond	Dielectric Voltage	ge Breakdown? Y or Measured Isolation Resistance, Ω		esistance, Ω
	SLine-1-1	Ν			

[X] Temperatures on windings [did] [did not] exceed the values noted in Table 40.1 for the class of insulation.

[] There [was] [was no] sign of ignition of the tissue or cheesecloth at the conclusion of the test.

[X] There [was] [was no] insulation breakdown during the Dielectric Voltage Withstand Test.

[] The isolation resistance [was] [was not] below the 50,000 ohms.



Report No.: PNS230710077 01001

Page 36 of 85

RESULTS				
DUT:	RS			
Test Date	2023-08-09			
Test Ambient, °C	26.6			
Insulation Class Temperature Limit, °C	65 65 65			
Type of Locked Rotor Protection:				
Dielectric voltage test value, V	168Vdc			
Isolation resistance voltage applied, Vdc	N/A			

Test:	Location of	Maximum	Ignition of
In Scooter or on Bench	Thermocouples	Temperature on	combustibles? Y
^	~	Windings, °C	or N
In Scooter, test with power supply and main control board	Winding	147.1	N
Dielectric Voltage Breakdown? Y or N		Measured Isolatio	n Resistance, Ω
N			
- -	In Scooter or on Bench In Scooter, test with power supply and main control board Dielectric Voltage Breakde	In Scooter or on Bench Thermocouples In Scooter, test with power supply and main control board Dielectric Voltage Breakdown? Y or N	In Scooter or on Bench Thermocouples Temperature on Windings, °C In Scooter, test with power supply and main control board Dielectric Voltage Breakdown? Y or N Measured Isolation

[X] Temperatures on windings [did] [did not] exceed the values noted in Table 40.1 for the class of insulation.

[] There [was] [was no] sign of ignition of the tissue or cheesecloth at the conclusion of the test.

[X] There [was] [was no] insulation breakdown during the Dielectric Voltage Withstand Test.

[] The isolation resistance [was] [was not] below the 50,000 ohm



Report No.: PNS230710077 01001

Page 37 of 85

WATER EXPOSURE TEST UL 2272,42

METHOD A

A fully charged DUT was subjected to a water exposure test in accordance with the Standard for degrees of Protection Provided by Enclosures (IP Code),

IEC 60529.; for protection against water indicated by the second characteristic numeral [4 (IPX4)]

The DUT was not operated during the water exposure.

After the water exposure, the DUT was subjected to a minimum of one discharge/charge cycle at the manufacturer's maximum specified values as noted under GENERAL. Following the cycle, the DUT was subjected to <u>a minimum 48 hour observation period</u>.

After the observation period, DUTs with hazardous voltage circuits were subjected to a dielectric voltage withstand test or isolation resistance test (without humidity conditioning).

At the conclusion of Method A, the DUT was examined for signs of ingress of water that would result in a hazardous condition. In general, if any water had entered, it shall not:

- be sufficient to interfere with the correct operation of the DUT or impair safety;
- deposit on insulation parts where it could lead to tracking along the creepage distances;
- reach live parts or windings not designed to operate when wet.

The tests were conducted with fresh water. During the IP tests the water temperature did not differ by more than 5 K from the temperature of the specimen under test.

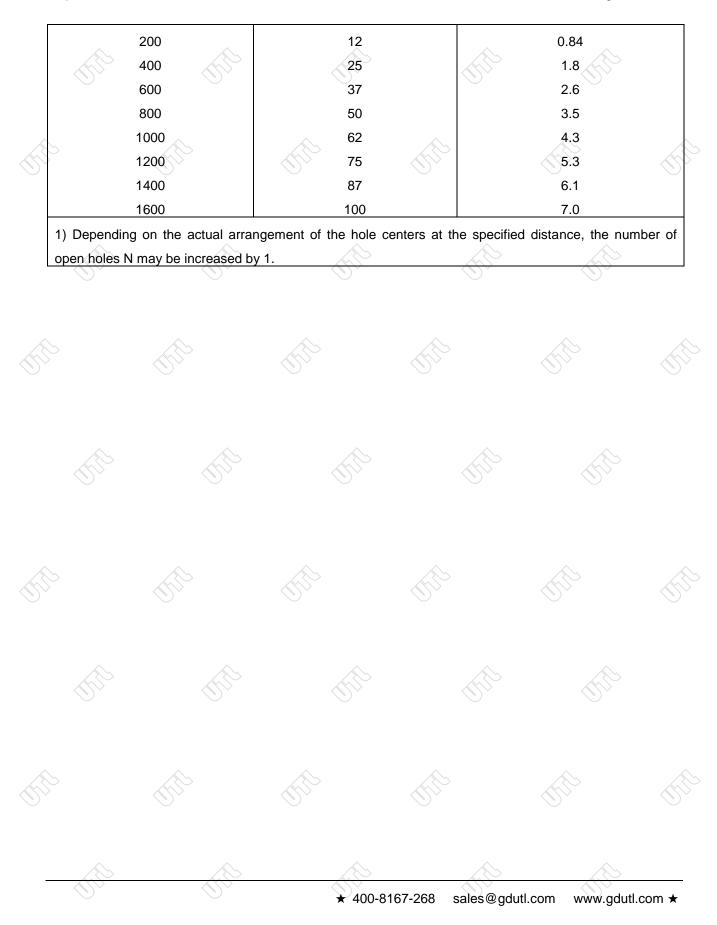
Note: During the test, dew which deposited on parts as a result of condensation was not considered evidence of ingress of water.

	Та	ble – Total	Water Flow Rate Qv Under	lpx4 Test Con	ditions –	
		Mea	an Flow Rate Per Hole QvI =	0.07 L/Min		
	Tube Radius	<u></u>		Degree IPX4		
\sim	R	-	Number of		Total water flow	Ś
	mm		open holes		qv	
			N1)		l/min	



Report No.: PNS230710077 01001

Page 38 of 85





Report No.: PNS230710077 01001

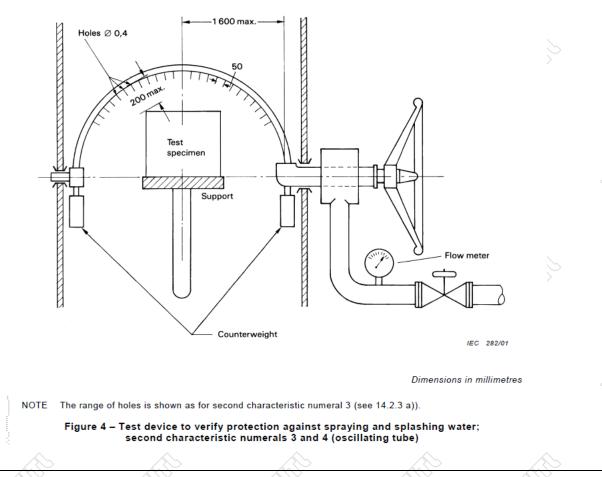
Page 39 of 85

The test was made using one of the two test devices described in figure 4 and in figure 5.

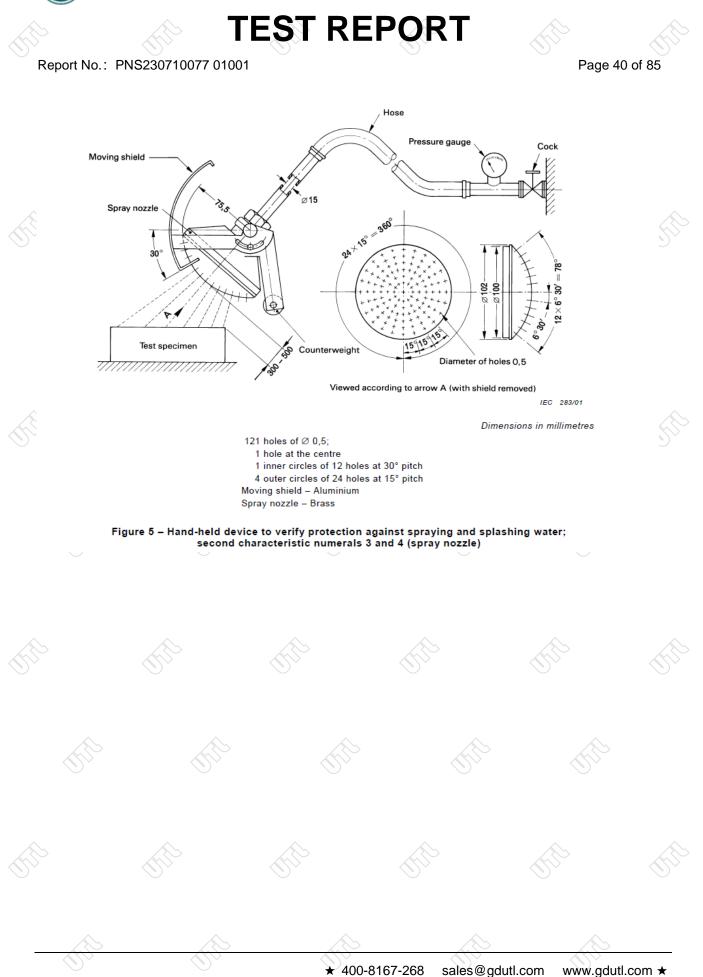
a) Conditions when using the test device of figure 4 (oscillating tube):

The oscillating tube had spray holes over the whole 180" of the semicircle. The total flow rate was adjusted as specified in the above table and was measured with a flow meter. The tube oscillated through an angle of almost 360° , 180° on either side of the vertical, the time for one complete oscillation (2 × 360°) was about 12 s. The duration of the test was 10 min. The support for the DUT was perforated to prevent it from acting as a baffle, and the DUT was sprayed from every direction by oscillating the tube to the limit of its travel in each direction.

b) Conditions when using the test device as in figure 5 (spray nozzle): The counterbalanced shield was removed from the spray nozzle and the enclosure was sprayed from all practicable directions. The water pressure was adjusted to give the specified delivery rate. The pressure to achieve this delivery rate was in the range of 50 kPa to 150 kPa, which was kept constant during the test. The test duration was 1 min/m2 of the calculated surface area of the DUT enclosure (excluding any mounting surface), with a minimum duration of 5 min.









Report No.: PNS230710077 01001

Page 41 of 85

	RESULTS	٩		
DUT		RS		
IP Rating:		IPX4		
Test Date		2023-08-10		Ś
Ambient Temperature, °C	Chille Chille	27.2		
Water Temperature, °C		26.6		
Water Pressure, psi		65kpa		
Test Device:		Spray Nozzle (Fi	gure 5)	
Tube Radius, mm		-		>
Water Flow Rate, I/min	0			
Dielectric voltage test value, V		168Vdc		
Isolation resistance voltage, Vdc		-		

	Sample	OCV at start before immersion,	OCV at conclusion of test, Vdc	Results
	No.	Vdc		
Γ	SLine-	83.2	83.1	N,O
	1-2		A	
		Dielectric Voltage Breakdown? Y	Measured Isolation Resistance,	State -
		or N	Ω	
	SLine-	Ν		
L	1-2			

	Results Key
E – Explosion	L – Electrolyte Leakage (external to enclosure)
F - Fire	S – Electric shock (dielectric breakdown or resistance below
	isolation resistance limits
R – Rupture	O – Operational after testing
	N - No evidence of noncompliant results

As a result of the water exposure, the DUT [did] [did not] catch on fire or explosion. There [was] [was no] evidence of rupture or external leakage of electrolyte when subjected to cycling after the exposure. There [was] [was no] evidence of ingress of water into electrical compartments that could result in a hazard.

[X] There [was] [was no] evidence of dielectric breakdown

[] The insolation resistance [was] [was not] less than 50,000 Ω .



Report No.: PNS230710077 01001

Page 42 of 85

METHOD B

(Partial Immersion)

The DUT immersed in water up to its foot supporting surface while oriented in its operating position as specified by the manufacturer. The water used for the test was a salt water solution (5% by weight NaCl in H2O).

The duration of the immersion was 5 min. The DUT was removed from the water and was then subjected for a minimum 48 hour observation period. If the DUT was operational, it was subjected to one charge/discharge cycle. If the DUT was not operational, it was still subjected to an attempt to charge it. The DUT was then subjected to a 1 hour observation period.

After the observation period, DUTs with hazardous voltage circuits were subjected to a dielectric voltage withstand test or isolation resistance test (without humidity conditioning).

The DUT was then examined for signs of ingress of water that would result in a hazardous condition. In general, if any water had entered, it shall not:

- be sufficient to interfere with the correct operation of the DUT or impair safety;
- deposit on insulation parts where it could lead to tracking along the creepage distances;
- reach live parts or windings not designed to operate when wet.

If the DUT's enclosure was provided with drain-holes, the DUT was examined to determine that any water that entered did not accumulate but drained away without creating a hazardous condition as noted above.

Note: During the test, dew which deposited on parts as a result of condensation was not considered evidence of ingress of water.





Report No.: PNS230710077 01001

Page 43 of 85

	RESULTS B
DUT	RS
Test Date	2023-08-10
Ambient Temperature, °C	27.2
Water Temperature, °C	26.5
Water Depth, mm	360
Dielectric voltage test value, V	168Vdc
Isolation resistance test voltage, Vdc	

					1
	Sample	OCV at start before	OCV at conclusion of test,	Results	
	No.	immersion, Vdc	Vdc		
	A5	83.4	0	W,N	
$\langle \rangle \rangle$	\sim	Dielectric Voltage	Measured Isolation		\mathbb{R}
		Breakdown? Y or N	Resistance, Ω		

	Results Key			
E – Explosion	L – Electrolyte Leakage	e (external to en	closure)	
F - Fire	S – Electric shock (di	ielectric breakd	own or resistance belo	sw
	 isolation resistance limi	ts	A	<u>_</u>
R – Rupture	0 – Operational after te	esting		
W – Water Ingress	N - No evidence of non) compliant result	s	

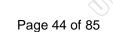
As a result of the water exposure, the DUT [did] [did not] catch on fire or explosion. There [was] [was no] evidence of rupture or electrolyte leakage.

Upon examination of the DUT, there [was] [was no] wetting of internal live parts that would result in a hazardous condition.

[X] There [was] [was no] evidence of dielectric breakdown.

[] The insolation resistance [was] [was not] less than 50,000 Ω .





Report No.: PNS230710077 01001

THERMAL CYCLING TEST UL 2272,43

METHOD

A fully charged DUT was subjected to a thermal cycling test as noted below.

For the test, the DUT was placed in a chamber with ambient air cycling at the temperature extremes of either $60 \pm 2^{\circ}$ C or $-20 \pm 2^{\circ}$ C. The transition period between exposure temperatures was 15 min or less.

Note: this test may be performed either through the use of a fast-response chamber, or by moving the DUT between two chambers at the two test temperatures.

The DUT remain at each extreme for as long as required for the DUT to reach a uniform temperature (±5 °C) of the chamber temperature but no less than 6 h.

A total of five cycles (at the high and low temperature extremes) were performed.

After the thermal cycling, the DUT was allowed to return to room ambient and then subjected to a discharge/charge cycle at the manufacturer's maximum specified values. If not operational, a charge was attempted. This was followed by an 1 h observation period as noted under GENERAL.

At the conclusion of the observation period, the DUT with hazardous voltage circuits was subjected to a dielectric voltage withstand test or isolation resistance test (without humidity conditioning).

The DUT was then examined for any signs of damage from the temperature conditioning that could result in a hazardous condition.



Report No.: PNS230710077 01001

Page 45 of 85

	RESULTS	
DUT:	RS	
Test Date:	2023-07-26 to 2023-07-29	
Ambient Temperature, °C	26.5/27.3/26.9/26.2	
Dielectric voltage test value, V	168Vdc	
Isolation resistance voltage, Vdc		\bigcirc
Test Temperatures, °C	Low:-20 High:60	

	High Temperature Conditioning			Low Temperature Conditioning		
	Average	Average	Duration at	Average	Average	Duration at
	Temp of	Temp of	High Temp,	Temp of	Temp of	Low Temp,
<u></u>	Chamber,	Sample, °C	h	Chamber,	Sample, °C	h
	°C			°C		
Model No.:	\bigcirc	\bigcirc		\bigcirc	\bigcirc	\bigcirc
Cycle 1	60.5		6.1	-20.5		6.1
Cycle 2	60.5		11.8	-20.3		6.1
Cycle 3	60.7	<u> </u>	6.2	-20.7		11.7
Cycle 4	60.3		6.1	-20.5	<	6.1
Cycle 5	60.3		11.8	-20.4		6.1

	Sample	Date/Time in	Date/Time	OCV at start, Vdc	OCV at end, Vdc	Results	
	No.	chamber	out of	S	\bigotimes		\sim
Ś	>		chamber		>		\geq
0	SLine-1-	2023-07-26	2023-07-29	83.2	82.8	N,O	
	1	9:20	15:55				_
		Dielectric E	Breakdown	Measured Isolati	on Resistance Ω		
		Υo	r Ń.				
	SLine-1- 1	N	20				

		Results Key
S)	E – Explosion	L – Electrolyte Leakage (external to enclosure)
	F - Fire	S – Electric shock (dielectric breakdown or resistance below
		isolation resistance limits



Report No.: PNS230710077 01001

Page 46 of 85

R – Rupture	O – Operational after testing	
	N - No evidence of noncompliant results	

As a result of the thermal cycling, the DUT [did] [did not] catch on fire or explosion. There [was] [was no] evidence of electrolyte leakage or rupture of the enclosure.

[X] There [was][was no] dielectric breakdown

[] The isolation resistance [was][was not] less than 50,000 Ω .





26

Report No.: PNS230710077 01001

OVERDISCHARGE TEST

METHOD

The fully charged DUT was subjected to a constant discharging current at the maximum discharging current specified by the manufacture under a single fault condition in the discharging circuit of the DUT that could lead to an overdischarge condition. Protective devices that had been determined reliable remained in the circuit. Cell voltages were measured to determine that they did not exceed specified end of discharge voltage limits. Temperatures were measured on a battery for monitoring purposes.

The test was continued until:

- •the DUT was fully discharged to a near zero voltage state or
- •protective devices remaining in the circuit operated, and the monitored temperatures return to
- ambient or steady state, or
- Explosion and/or fire occurred.

If the DUT was operational after the test, it was subjected to a minimum of one charge/discharge cycle at the manufacturer's maximum specified value. If not operational a charge was attempted. The test was followed by a one hour observation period.

At the conclusion of the observation period, a DUT with hazardous voltage circuits was subjected to an Isolation Resistance Test (without humidity conditioning) or a Dielectric Voltage Withstand Test.





Report No.: PNS230710077 01001

OVERDISCHARGE TEST (CONT'D):



26

RESULTS

Dielectric voltage test value, V 168Vdc	0
Isolation resistance limit, Ω/ Ω/Vdc	
Lab Ambient, C 26.5/25.7	

	Sample	OCV at	Fault	Measured	OCV at end	Maximum	Results
	No.	start of	Condition	Maximum	of Test, Vdc	Temp-	
	~	Test, Vdc	Imposed	Discharge	~	erature,	
\langle			Ú.	Current, A		°C	
J	SLine- 2-2	Normal	100	66.7	55.215	2.743	Y
	SLine- 1-1	Short Q59 Pin D-S	60.8	65.1	61.694	3.06	Y

Results Key	
E – Explosion	L – Electrolyte Leakage (external to enclosure)
F - Fire	S – Electric shock (dielectric breakdown or resistance below
	isolation resistance limits
C – Combustible Concentrations	P – Loss of protection controls
R – Rupture	N - No evidence of noncompliant results
O – Operational after testing	

As a result of the overdischarge test, the DUT [did] [did not] catch on fire or explode. There [was] [was no] rupture resultingin electrolyte leakage from the DUT enclosure or exposure of hazardous parts.

[] There [was][was no] evidence of combustible concentrations.

[X] There [was][was no] evidence of dielectric breakdown.

[] The isolation resistance measurements [were][were not] below acceptable values.



Report No.: PNS230710077 01001

OVERCHARGE

METHOD

A fully charged DUT was discharged at a 0.2C constant discharge rate or higher discharge rate permitted by the manufacturer to the manufacturer's specified EODV.

The DUT was then subjected to a constant current charging at the manufacturer's maximum specified charging rate and under a single fault condition in the circuitry that directly controls the charging line of the DUT that could lead to an overcharge conditions. Protective devices determined reliable in accordance with 18.5 of UL 2271/ULC S2271 were allowed to remain in the circuit.

For information purposes, temperatures were monitored on the cell/module where temperatures may be highest.

The test was continued until the voltage had reached 110% of the maximum specified voltage limit and monitored temperatures returned to ambient or steady state conditions and an additional 2 hours had elapsed, or explosion /fire occurred.

If the DUT was operational after the tests, it was subjected to a minimum of one charge/discharge cycle at the manufacturer's maximum specified values as noted under GENERAL. The test was followed by an observation period as noted under GENERAL.

At the conclusion of the observation period, the samples with hazardous voltage circuits were subjected to a dielectric voltage withstand test or isolation resistance test (without humidity conditioning).

If a protective device in the circuit operated, the test was repeated at 90% of the trip point of the protection device or at some percentage of the trip point that allows charging for at least 10 minutes.

23

Page 49 of 85



Report No.: PNS230710077 01001

Page 50 of 85

23

OVERCHARGE (CONT'D):

RESULTS

LR1726V
168Vdc
- ~ ~
10A 🕥 🔊 🔊
83.8Vdc
92.18V
26.1/26.8
-

Sample No.	OCV at start of Test, Vdc	Fault Condition Imposed	Measured Maximum Charge Current, A	Measured Max Charge Voltage, Vdc	Maximum Temp- erature, °C	Results	
SLine- 2-2	First	Short Q66 Pin D-S	29.4	83.908	4.2	Y	
SLine- 2-2	First	Short Q65 Pin D-S	29.6	85.984	4.302	Y	\otimes

	Voltage measure location (see illustration	Measured Max cell voltage	Specified upper limit
	in temperature test)	during non-fault condition,	charging voltage, Vdc
	~ ~ ~	Vdc	~
	Fault: Short Q66 Pin D-S		
	Cell No. 1	4.195	4.325
	Cell No. 2	4.198	4.325
	Cell No. 3	4.198	4.325
	Cell No. 4	4.200	4.325
	Cell No. 5	4.195	4.325
	Cell No. 6	4.199	4.325
	Cell No. 7	4.198	4.325
9	Cell No. 8	4.196	4.325
	Cell No. 9	4.192	4.325
	Cell No. 10	4.195	4.325
	Cell No. 11	4.195	4.325
	Cell No. 12	4.195	4.325
	Cell No. 13	4.195	4.325
	Cell No. 14	4.192	4.325
	Cell No. 15	4.191	4.325
	Cell No. 16	4.196	4.325
	Cell No. 17	4.194	4.325
	Cell No. 18	4.193	4.325
	Cell No. 19	4.196	4.325
	Cell No. 20	4.195	4.325



Report No.: PNS230710077 01001

Page 51 of 85

Voltage measure location (see illustration	Measured Max cell voltage	Specified upper limit charging
in temperature test)	during non-fault condition,	voltage, Vdc
	Vdc	
Fault: Short Q65 Pin D-S		\bigcirc \sim
Cell No. 1	4.302	4.325
Cell No. 2	4.300	4.325
Cell No. 3	4.300	4.325
Cell No. 4	4.299	4.325
Cell No. 5	4.297	4.325
Cell No. 6	4.300	4.325
Cell No. 7	4.301	4.325
Cell No. 8	4.299	4.325
Cell No. 9	4.298	4.325
Cell No. 10	4.300	4.325
Cell No. 11	4.298	4.325
Cell No. 12	4.299	4.325
Cell No. 13	4.297	4.325
Cell No. 14	4.297	4.325
Cell No. 15	4.298	4.325
Cell No. 16	4.299	4.325
Cell No. 17	4.299	4.325
Cell No. 18	4.297	4.325
Cell No. 19	4.302	4.325
Cell No. 20	4.302	4.325

Results Key				
E – Explosion L – Electrolyte Leakage (external to enclosure)				
F - Fire	S – Electric shock (dielectric breakdown or resistance below isolation resistance limits			
C – Combustible Concentrations	P – Loss of protection controls			
R – Rupture	N - No evidence of noncompliant results			

As a result of the overcharge test, the DUTs [did] [did not] catch on fire or explode. There [was] [was no] rupture resultingin electrolyte leakage from the DUT enclosure or exposure of hazardous parts.

[] There [was][was no] evidence of combustible concentrations.

[X] There [was][was no] evidence of dielectric breakdown.

[] The isolation resistance measurements [were][were not] below acceptable values.



Report No.: PNS230710077 01001

Page 52 of 85

27

IMBALANCED CHARGING TEST

METHOD

A fully charged DUT was discharged down to its EODV with the exception of one cell/cell block. The one cell/cell block was discharged to approximately 50% of its SOC to create an imbalanced condition in the DUT.

The imbalanced DUT was then charged in accordance with the manufacturer's specifications. The voltage of the partially charged cell/cell block was monitored during charging to determine if its voltage limits were exceeded.

If the DUT was operational after the tests, it was subjected to a minimum of one charge/discharge cycle at the manufacturers' maximum specified values as noted under GENERAL. The DUT was then subjected to an observation period as noted under GENERAL.

At the conclusion of the observation period, the DUT with hazardous voltage circuits was subjected to an isolation resistance test (without humidity conditioning) or a dielectric voltage withstand test.



Page 53 of 85

27

Report No.: PNS230710077 01001

IMBALANCED CHARGING Test (CONT'd):

RESULTS

Lab Ambient, °C $26.1/25.4$ Dielectric voltage test value, V $168Vdc$ Isolation resistance limit, $\Omega/\Omega/Vdc$	DUT:		LR1726V	
	Lab Ambient, °C		26.1/25.4	
Isolation resistance limit, $\Omega/\Omega/Vdc$	Dielectric voltage test value, V		168Vdc	
	Isolation resistance limit, $\Omega/\Omega/Vdc$			

Sample No	OCV of pack after charging, Vdc	Maximum voltage of monitored cell(s), V	Maximum current of monitored cell(s),A	Max Temp on monitored cells, °C	Results
SLine- 2-1	<u>}-</u>	3.595	4.198	Short Q66 Pin D-S	28.3
SLine- 2-1		3.590	4.3	Short Q65 Pin D-S	29.8

	Results Key
E – Explosion	L – Electrolyte Leakage (external to enclosure)
F - Fire	S - Electric shock (dielectric breakdown or resistance below
	isolation resistance limits
C – Combustible Concentrations	P – Loss of protection controls
R – Rupture	N - No evidence of noncompliant results
O – Operational after testing	

The DUT [did] [did not] catch on fire or explode. There [was] [was no] venting orrupture resulting in electrolyte leakage from the DUT enclosure or exposure of hazardous parts.

The maximum voltage limit of the monitored cell/cell block [was] [was not] exceeded when subjected to maximum normal charging conditions.

[] There [was][was no] evidence of combustible concentrations.

[X] There [was][was no] evidence of dielectric breakdown.

[] The isolation resistance measurements [were][were not] below acceptable values



Report No.: PNS230710077 01001

Page 54 of 85

UL 2580 - ULC 2580, B2.7

SHORT CIRCUIT TEST (CONT'D):

METHOD (CONT'D)

C) CID - if a CID operates during the test, the testing was repeated on the remaining samples as follows:

1. The test was conducted as a full short circuit test for all samples, with no repeat testing at loads below a protector trip point level.

D) Fusible Tabs/Connections – If a fusible tab or connector operated during the test, the testing was repeated on the remaining samples as follows:

1. The test was conducted as a full short circuit test for all samples, with no repeat testing at loads below a protector trip point level.

E) Fuse – If a fuse operated during the test, the testing was repeated on the remaining samples with the discharge load set to just below the trip point level (operating parameters) of the fuse.

Placement of Samples:

Samples shall not be placed on a conductive surface and shall not be touching during the test.

Note to Technician:

Safety Information - See safety information at beginning of data package prior to testing including information regarding testing of larger cells. Samples are not to be handled until they have reached safe temperatures (example \pm 10°C from ambient).



Page 55 of 85

Report No.: PNS230710077 01001

SHORT CIRCUIT TEST (CONT'D):

RESULTS

UL 2580 - ULC 2580, B2.7

	Model	INR21700-50E++
Ś	Room Ambient, °C	22.4
	Oven Temperature, °C	25.2
	Maximum Charge Current, A	4.9
	Maximum Charge Voltage, V	4.325

[] The following protective device was shorted prior to testing:

[] large cell, should be isolated when tested.

Note: Use load cell to determine the maximum trip and no-trip values.

Sample No.	Cell Condition	Initial OCV, Vdc	Total Load Resistance of Circuit, mΩ (#)	Maximum Short Circuit Current, A	Maximum Temperatur e of Cell Case, °C	Results Evidence of: [N][F][E][R]
SLine-4-5	4.31	0	4.5	136.6		N
SLine-4-7	4.302	0	4.5	123.0		N
SLine-8-8	4.3	0	4.5	127.6		N
# - Must be ≤ Results Key: N – No evide	nce of fire, explo	osion or rupture	e Ji	Ś		
F – Evidence E – Evidence R – Evidence	of explosion					

As a result of the test, there [was][was no] evidence of rupture, fire, or explosion of the cells.



Report No.: PNS230710077 01001

Page 56 of 85

OVERCHARGE TEST:

UL 2580 – ULC 2580, B2.8

METHOD

The overcharge test was performed as follows:

a) The SOC of cell was adjusted to 100 % in accordance with the SOC ADJUSTMENT method noted above.

b) The cell was then continued to be charged beyond the 100 % SOC with a maximum specified charging current of _____ A, at room temperature using a power supply sufficient to provide the constant charging current.

The overcharge test was discontinued when the voltage of cell reached 120 % of maximum specified charge voltage, or the quantity of electricity applied to the cell reached the equivalent of 130 % SOC, whichever came first.

Note to Technician: Safety Information - See safety information at beginning of data package prior to testing including information regarding testing of larger cells. Samples are not to be handled until they have reached safe temperatures (example \pm 10°C from ambient).



Report No.: PNS230710077 01001

Page 57 of 85

	OVERCHARGE TEST (CONT'D):	UL 2580 – ULC 2580, B2.8
	RESI	ULTS
	Model	INR21700-50E++
	Room Ambient, °C	23.4
2	Maximum Charge Current, A	4.9
	Maximum Charge Voltage, V	4.325
	0.2 C Discharge Current, A	0.98
	End of Discharge Voltage (EODV), V	2.5
	Rated Capacity, Ah	4.9
	120% of Maximum Charge Voltage, V	6.228
5	130% of SOC, Ah	6.37

[] large cell, should be isolated when tested.

Sample No	Initial OCV,	Charge	End OCV, V	Charging	Maximum	Results
~	V	Current, A		Time to overcharge, hh:mm (#)	Temperatur e of Cell Case, °C	Evidence of: [N][F][E][R]
SLine-4-4	4.31	4.87	0.3	30.2	4.9	N 🖉
SLine-4-6	4.305	4.875	0.3	29.8	4.9	N
SLine-4-9	4.301	4.882	0.3	30.0	4.9	N
Results Key:	neasured when o			Ś		Star.
Results Key:	nce of fire, explo			Ś		- Star
Results Key: N – No evide F – Evidence	nce of fire, explo					J.

As a result of the test, there [was][was no] evidence of rupture, fire, or explosion of the cells



Report No.: PNS230710077 01001

Page 58 of 85

UL 2580 - ULC 2580, B2.5

HEATING TEST:

METHOD

The test was performed as follows:

a) The SOC of cell was adjusted to 100 % for BEV application, and to 80 % for HEV application in accordance with SOC ADJUSTMENT method noted above.

b) The cell, stabilized at room temperature in accordance with the TEMPERATURE STABILIZATION method noted above, was placed in a gravity or circulating air-convection oven. The oven temperature was raised at a rate of 5 °C/min to a temperature of 130 °C \pm 2 °C. The cell remained at this temperature for 30 min before the test was discontinued.

NOTE: If necessary, to prevent deformation, the cell may be maintained during the test in a manner that does not violate the test purpose.

Note to Technician: Safety Information - See safety information at beginning of data package prior to testing including information regarding testing of larger cells. Samples are not to be handled until they have reached safe temperatures (example $\pm 10^{\circ}$ C from ambient).

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Report No.: PNS230710077 01001

Page 59 of 85

HEATING TEST (CONT'D):



RESULTS

D	Model	INR21700-50E++
	Room Ambient, °C	24.9
	Maximum Charge Current, A	4.9
	Maximum Charge Voltage, V	4.325
	Target Oven Temperature, °C	130
	Time at Target Oven Temperature	[10 min] [30 min]
Ň		

Sample No.	Initial OCV, V	Comments
		Evidence of: [N][F][E][R]
SLine-4-1	4.31	N
SLine-4-2	4.30	Ν
SLine-4-3	4.31	N
Results Key:		
N – No evidence of fire, explosion of	or rupture	
F – Evidence of fire E – Evidence of explosion R – Evidence of rupture		

As a result of the test, there [was][was no] evidence of fire, explosion, or rupture of the cells.



Report No.: PNS230710077 01001

Page 60 of 85

UL 2580 - ULC 2580, B2.10

PROJECTILE TEST:

METHOD

The test was conducted at room temperature $25 \pm 5^{\circ}$ C.

Each sample was charged at the maximum charging rate specified by the manufacturer until fully charged. The temperature was then be allowed to stabilize at room ambient.

Each sample was placed on a screen that covers a 102 mm (4 in) diameter hole in the center of a platform table. The screen was constructed of steel wire mesh having 20 openings per 25.4 mm (1 in) and a wire diameter of 0.43 mm (0.017 in).

The screen was mounted 38 mm (1-1/2 in) above a Meker type burner. The fuel and airflow ratio were set to provide a bright blue flame that caused the supporting screen to glow a bright red.

An eight-sided covered wire cage made from metal screening, with dimensions noted below, was placed over the test sample:

-	[610 mm (2 ft)] / [_mm] across; and

[305 mm (1 ft)] / [_____mm] high.

The size of the wire test cage was allowed to be adjusted from the original 610 mm by 305 mm standard dimensions for larger cells so that it measured about 305 mm (1 ft) from the edges of the cell under test.

The metal screening of the wire cage was constructed from a single layer of 0.25 mm (0.010 in) diameter aluminum wire with 16 to 18 wires per 25.4 mm (1 in) in each direction. The aluminum screening was free from holes and secured tautly around the test cage frame.

[] The test cage was replaced by a visible circular perimeter marking on the supporting surface located 0.5 m (19.7 in) from the longest side of the cell. The marking was no greater than 5-mm (0.2-in) thick. The test set-up was located within a protective enclosure/room with noncombustible surfaces located a distance from the test perimeter marking where any projectiles that fall beyond the test perimeter marking were safely contained.



Report No.: PNS230710077 01001

Page 61 of 85

PROJECTILE TEST (CONT'D):

UL 2580 - ULC 2580, B2.10

METHOD (CONT'D)

The sample was heated and remained on the screen until it exploded was ignited and burned out. The sample was not required to be secured in place unless it was at risk of falling off the screen before ultimate results were obtained. If required, the sample was secured to the screen with a single wire tied around the sample.

Note to Technician: The securement wire is only utilized if the sample will not remain above the flame during the test to achieve ultimate results.

In this case the single wire utilized should be the minimal thickness necessary to hold the battery in place.

If one of the first set of samples penetrated the screen, a second set of samples was allowed to be tested.

Note to Technician: Safety Information - See safety information at beginning of data package prior to testing including information regarding testing of larger cells. Samples are not to be handled until they have reached safe temperatures (example \pm 10°C from ambient).





Page 62 of 85

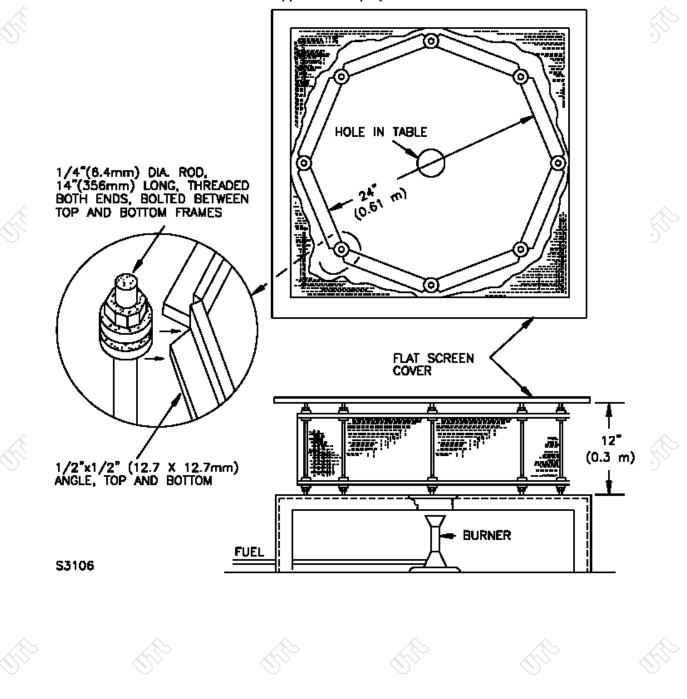
UL 2580 - ULC 2580, B2.10

Report No.: PNS230710077 01001



METHOD (CONT'D)

Test apparatus for projectile test





Report No.: PNS230710077 01001

Page 63 of 85

PROJECTILE TEST (CONT'D):

RESULTS

UL 2580 – ULC 2580, B2.10

ModelINR21700-50E++Room Ambient, °C22.5Maximum Charge Current, A4.9Maximum Charge Voltage, V4.325

Sample No.	Initial OCV, V	Comments	
SLine-4-11	4.302	2	
SLine-4-12	4.305	2	~
SLine-4-10	4.310	2	X

Comments Key

- (1) Cell did not explode.
- (2) Cell exploded but no part of the cell casing penetrated the wire screen.
- (3) Cell exploded such that particles from the casing penetrated the wire screen.
- (4) Cell vented without exploding.
- (5) Other.

The results [were][were not] in compliance.



Report No.: PNS230710077 01001

Page 64 of 85

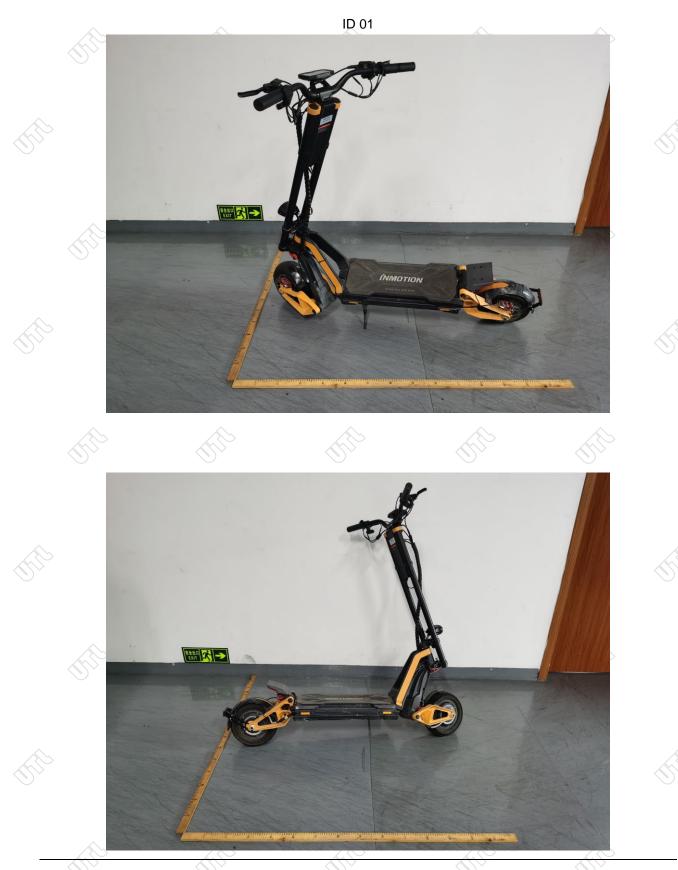
	Enclosures	<u> </u>	<u></u>	
Supplement Id		Description		
01	Overall View			
02	Internal View		<u></u>	
03	Overall View for Motor	STR.		
04	Overall View for main board			
05-1, 05-2	Main board view			
06	Overall view for battery pack			
07	Specification			
08	Critical components information			
09	Schematics for main board			
10	PCB Layout for main board			
11	Drawing			
12	Drawing for Motor			
13	Marking Label			





Report No.: PNS230710077 01001

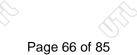




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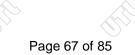
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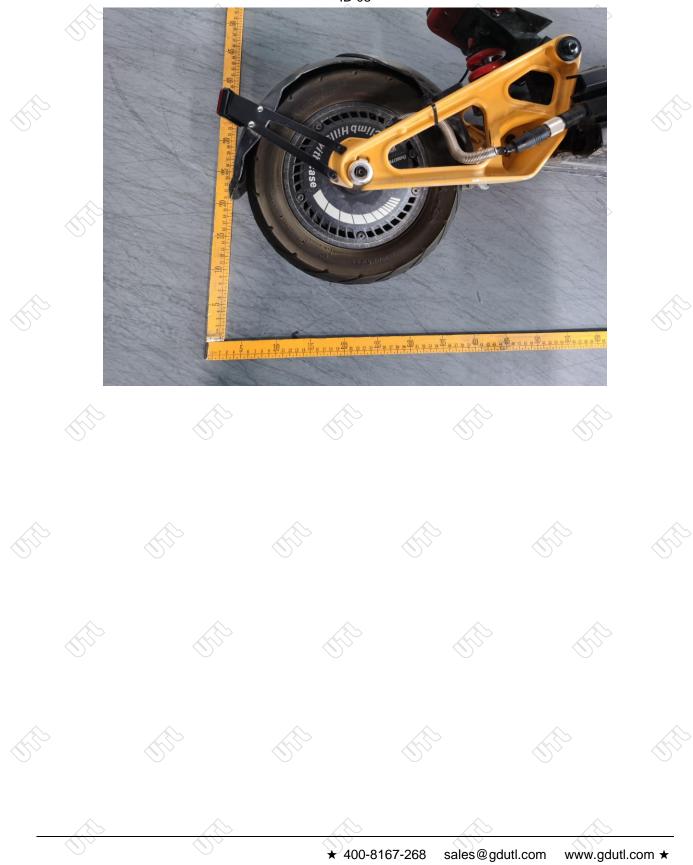




Report No.: PNS230710077 01001









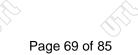
Report No.: PNS230710077 01001

Page 68 of 85





Report No.: PNS230710077 01001



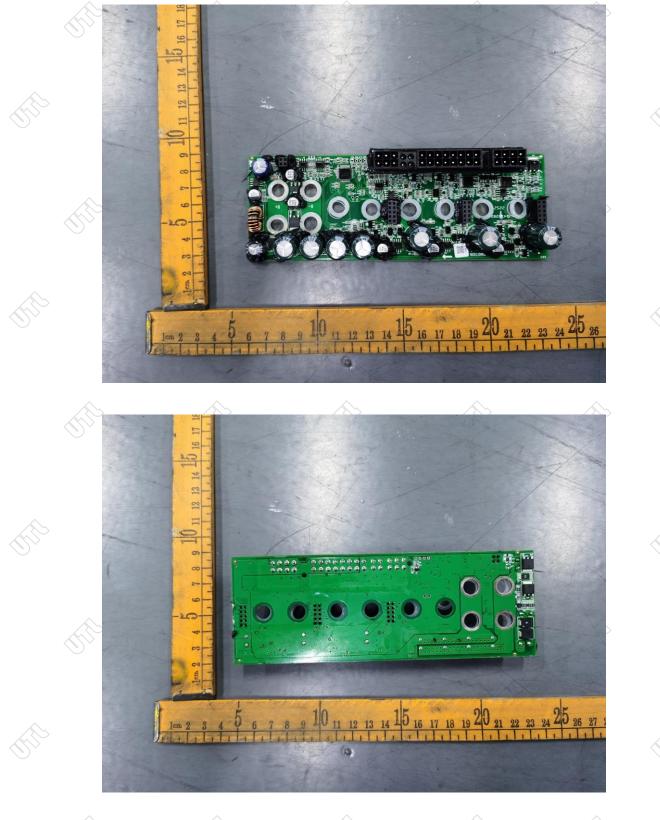




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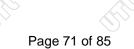


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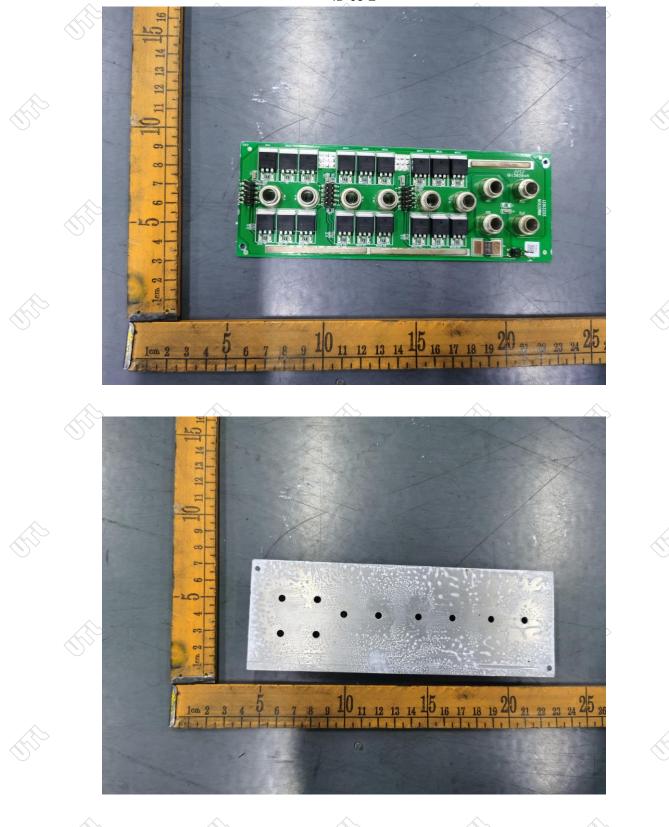




Report No.: PNS230710077 01001

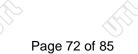


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Report No.: PNS230710077 01001



ID 06-1





Report No.: PNS230710077 01001



ID 06-2





Report No.: PNS230710077 01001

Page 74 of 85

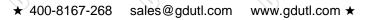
		ID 07		
COMPONENT CELL:		\sim	BATTERY :	
Manufacturer	S	Samsung SDI Co Ltd	Manufacturer	HUIZHOU BLUEWAY ELECTRONICS CO., LTD.
Model	I	NR21700-50E++	Model	LR1726V
Туре	L	i-ion	Configuration: XP/YS	20S8P
Capacity	4	.900mAh	Capacity	39.2Ah
Voltage Rating	3	9.63V	Voltage Rating	72.6V
Standard Charging Co	urrent 2	2.45A	Standard Charging Current	10.0A
Standard Full Chargir Voltage	g 4	.2V	Standard Full Charging Voltage	83.8V
End of Charging Curre	ent 9	18mA	End of Charging Current	100mA
Maximum Charging C	urrent 4	.9A	Maximum Charging Current	10A
Upper Charging Volta	ge Limit 4	.325V	Maximum Charging Voltage	83.8V
Standard Discharging	Current 4	.9A	Standard Discharging Current	7.84A
Discharge End Point	/oltage 2	2.5V	Discharge End Point Voltage	55.0V
Maximum Discharge	Ourrent 9	9.8A	Maximum Discharge Current	100A
Charging Temperatur	e Range	-45°C	Charging Temperature Range	0-45
Discharging Tempera Range	ture	20-60°C	Discharging Temperature Range	-20-60
Upper Limit of Cell su Temperature, °C		0℃ for charge and 0℃ for discharge	Overcharge Voltage Protection	0,



Report No.: PNS230710077 01001

Page 75 of 85

CHARGER:		PERSONAL E- MOBILITY DEVICE:	
Model No.	AP-PF600CH08360050	Type of Device	
Manufacturer	Shenzhen Shi Alrightpower Technology Co Ltd	Model No.	RS
Input Voltage Rating	100-240Vac, 50/60Hz	Manufacturer	INMOTION TECHNOLOGIES CO., LTD
Output Voltage Rating:	83.8V Max.	Electrical Ratings (volts, current and/or power)	84Vdc, 40Ah
Input Current Rating	8.00A Max.	Weight of device, lbs/kg	58kg
Output Current Rating	5±5%	Max Weight Limit, kg	150kg
MOTORS:	\bigcirc	Max Speed, mph	110km/h
Model No.	RS Motor	IP rating	IPX4
Manufacturer	Jinyuxing Electromechanical Technology (Zhejiang) Co., Ltd	Specified maximum angle of operation	26
Motor Type	DC	Provided with Handle (s)	
Insulation Class	CLASS A	Specified operating ambient range, C	-10~40°C
Specified Voltage	72V	Specified charging ambient range, C	-10~40℃
Specified Current/Wattage	2000W*2, 50A MAX.	Minimum Rider Age	16
Specified Torque			





Report No.: PNS230710077 01001

Page 76 of 85

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	Object / part No.	Manufacturer/ trademark	Type / model	Technical data	Standard	Mark(s) of conformity1)
	Battery Pack	HUIZHOU BLUEWAY ELECTRONICS CO., LTD.	LR1726V	Rated 83.8Vdc, 38.4Ah		Test with appliance
	Charger	SHENZHEN ALRIGHTPOWER TECHNOLOGY CO., LTD	AP- PF600CH084 00050	INPUT: 100-240V~ 50/60HZ 420W OUTPUT: 84Vdc 5A	UL 1012	UL E522594
	РСВ	CHENG YI ELECTRONICS (JIAXING) CO LTD	CY-M	V-0, 130 °C	UL 796	UL E225328
	PCB (Alternative)	Interchangeable	Interchangeab le	FR-4,V-0, 130°C	UL 796	UL
	Motor	Jinyuxing Electromechanical Technology (Zhejiang) Co. , Ltd	RS Motor	72V, 2000W		Tested with appliance
<u> </u>	Controller	Tianjin Santroll Electric Technology Co., Ltd.	C- WZKD7250A- LX-LR1-18G	Max. 90V, Max. 52A		Tested with appliance
	Plastic enclosure	FORMOSA CHEMICALS & FIBRE CORP PLASTICS DIV	AC310(+)	V-0, 60°C	UL 94	UL E162823
	Plastic enclosure (Alternative)	Interchangeable	Interchangeab le	V-1, 80°C	UL 94	UL
	Internal wire	DONGGUAN DEWEL ELECTRONIC CO LTD	1332	300V, 200°C	UL 758	UL E339716



Report No.: PNS230710077 01001

Page 77 of 85

Object / part No.	Manufacturer/ trademark	Type / model	Technical data	Standard	Mark(s) of conformity1)
Internal wire (Alternative)	Interchangeable	Interchangeab le	300V, 200°C	UL 758	UL
Battery Pack					
PCB	SUNKING CIRCUITS ELECTRONICS CO LTD	SK-06	V-0, 130°C Thickness:1.6mm	UL 796	UL E326765
FUSE(F2, F3)	ADVANCED SURGETECH MATERIALS LTD	A121001-100	125VDC,100A	UL 248-1 UL 248-2-14	UL E470032
FUSE(F1)	ZHONG SHAN LANBAO ELECTRICAL APRLIANCES CO LTD	6125SB20A12 5V	125V, 20A	UL 248-1 UL 248-2-14	UL E213695
Connector (J1, J2)	Suzhou YSTZ Electronic Technology Co Ltd	A1001VS- 2*10P	-20°C to 85°C DC 50V	UL 1977	UL E521828
MOS (Q59,Q58, Q57, Q54, Q53,Q73, Q72, Q71)	Wuxi NCE power Co Ltd	NCEP028N12 LL	V _{DSS} =120V, I _D =230A, V _{GSS} =±20V,		Tested with appliance
MOS (Q66, Q65, Q1)	Wuxi NCE power Co Ltd	NCEP050N12 D	V _{DSS} =120V, I _D =130A, V _{GSS} =±20V		Tested with appliance
Sampling resistor (R281, R280, R279, R276, R127, R277, R141, R135, R134)			2mΩ,3W		Tested with appliance
IC (U3)	Qingdao Eastsoft Communication Technology Co., Ltd.	ES32F0283	V _{DD} : 1.8-5.5V, T _{OPR} : -40~85°C	-	Tested with appliance
IC (U1,U2)	CellWise Microelectronics Co., Ltd.	OZ7716	Vdd: 6-72V, Topr: -40~85°C		Tested with appliance



Report No.: PNS230710077 01001

Page 78 of 85

	Object / part No.	Manufacturer/ trademark	Type / model	Technical data	Standard	Mark(s) of conformity1)		
	IC (U13, U12, U7, U6)	CellWise Microelectronics Co., Ltd	CW1051ALG M	V _{DD} : -0.3-36V, T _{OPR} : -30~85°C		Tested with appliance		
	IC (U9)	SG Micro Corp	SGM8477-1	Vdd: 1.8-5.5V, Topr: -40~125°C	- 55	Tested with appliance		
	Controller							
	MCU (U1)	NATION	N32L406CBL 7	V _{DD} : 1.8-3.6V, T _{OPR} : -40~105°C		Tested with appliance		
	Power IC (U8)	Dongguan Huihai Semiconductor Co.,Ltd	H6201L	Output voltage: 5- 30V		Tested with appliance		
	Power IC (U15)	Microne	78M05	output voltage: 4.75V-5.25V		Tested with appliance		
	Power IC (U7)	SHIKUES	1117-3.3V	Output voltage: 3.235V-3.365V	500	Tested with Appliance		















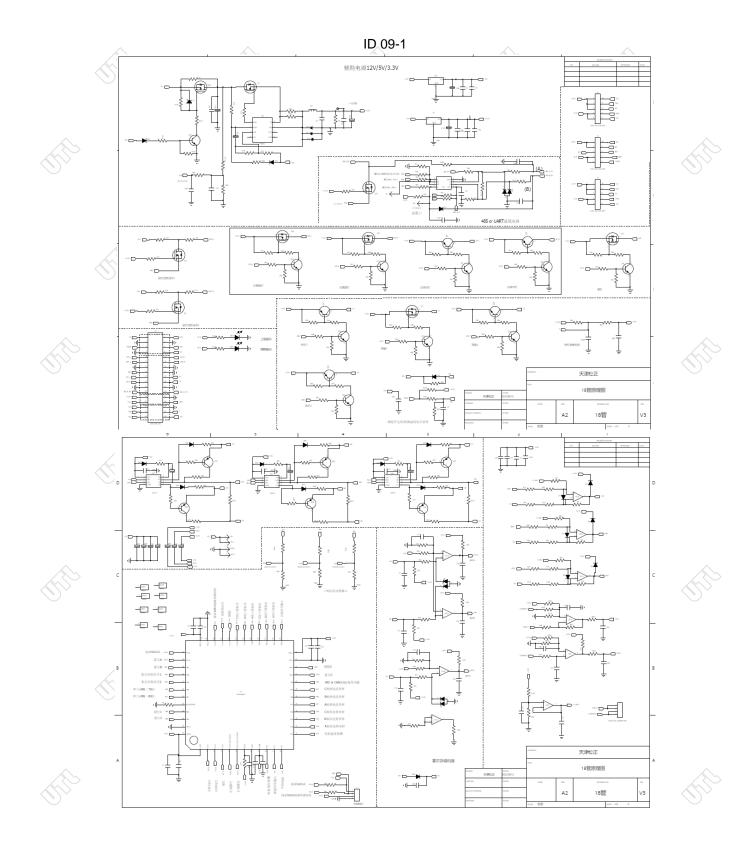


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Report No.: PNS230710077 01001

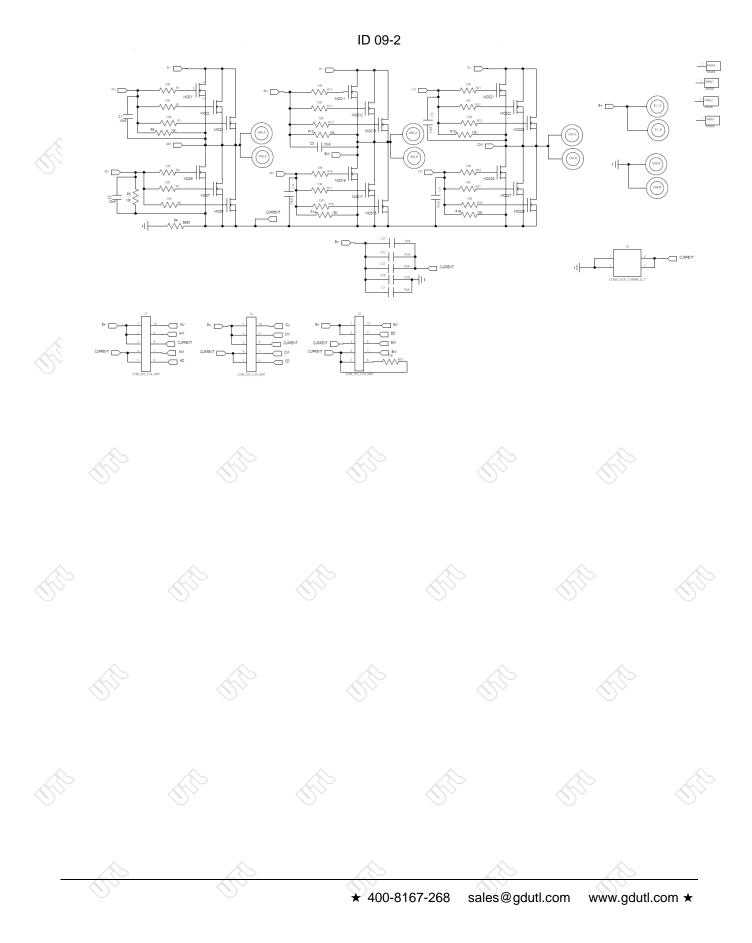
Page 79 of 85





Report No.: PNS230710077 01001

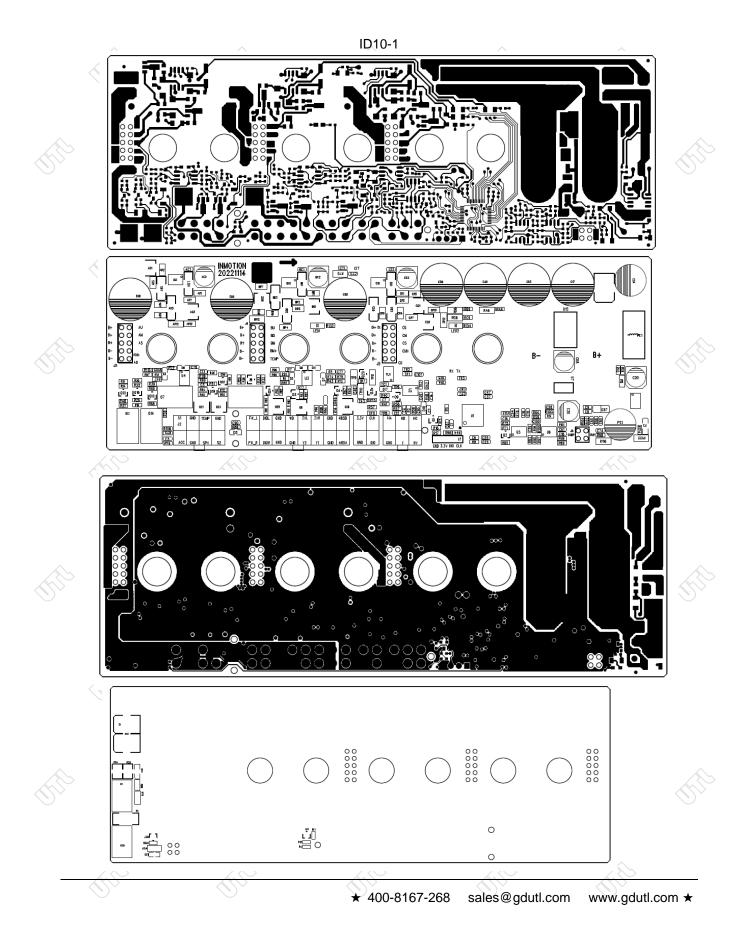
Page 80 of 85





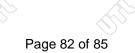
Report No.: PNS230710077 01001

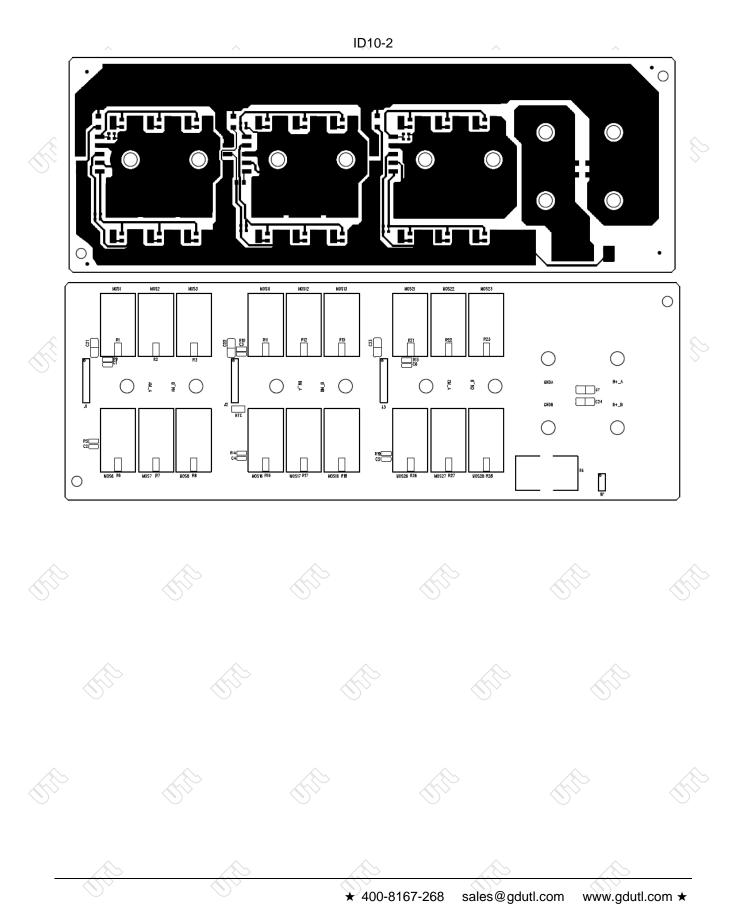
Page 81 of 85





Report No.: PNS230710077 01001

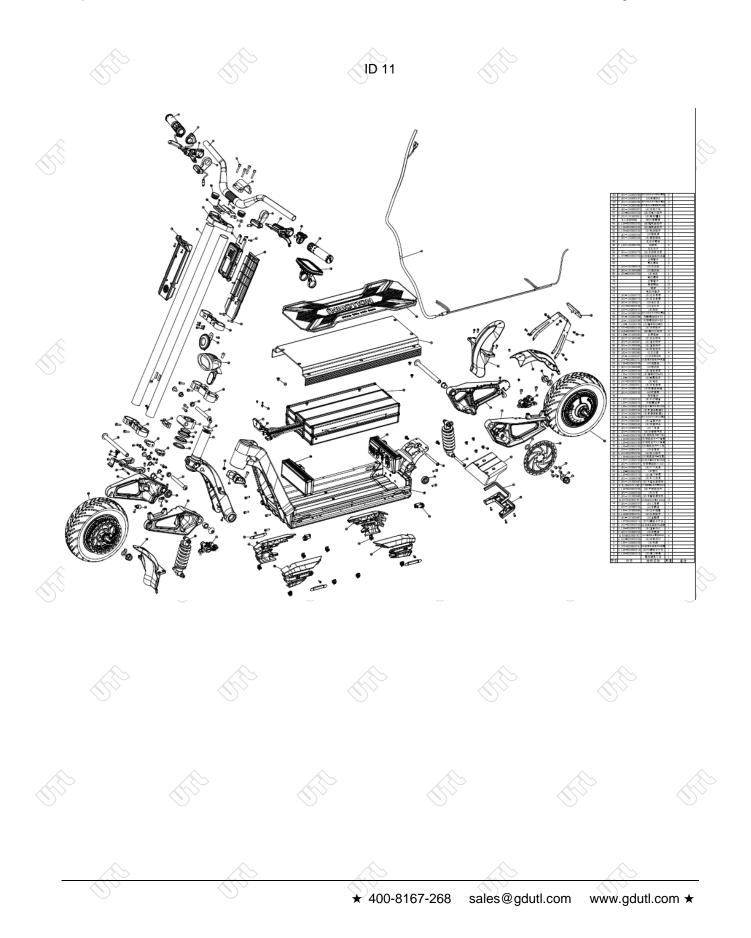






Page 83 of 85

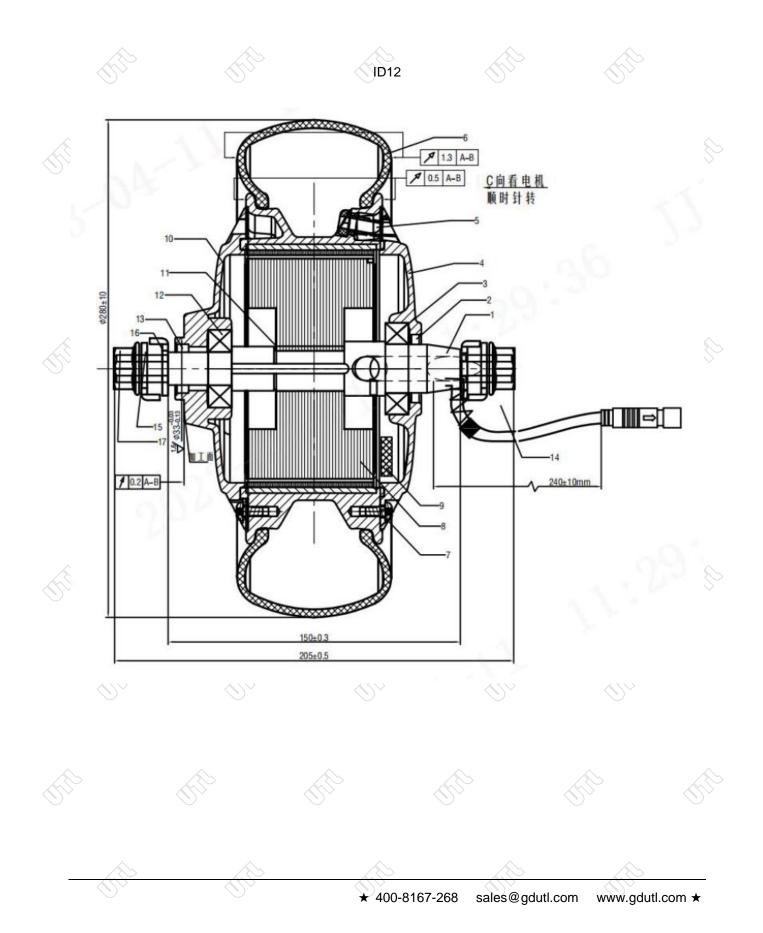
Report No.: PNS230710077 01001





Report No.: PNS230710077 01001

Page 84 of 85





Report No.: PNS230710077 01001

Page 85 of 85

